

TITANIUM-CONTAINING PRECURSORS FOR VAPOR DEPOSITION

Cross-Reference to Related Applications

5 This application is a continuation-in-part of prior Application No. 12/981,872, filed December 30, 2010, which claims benefit under 35 U.S.C. § 119(e) to provisional application No. 61/321,763, filed April 7, 2010, the entire contents of both being incorporated herein by reference.

Technical Field

10 Disclosed are titanium-containing precursors, methods of synthesizing the same, and methods of using the same to deposit titanium-containing layers using vapor deposition processes.

Background

15 One of the serious challenges the semiconductor industry faces is developing new gate dielectric materials for DRAM and capacitors. For decades, silicon dioxide (SiO_2) was a reliable dielectric, but as transistors have continued to shrink and the technology has moved from "Full Si" transistors to "Metal Gate/High-k" transistors, the reliability of the SiO_2 -based gate dielectric is reaching its physical limits. The need for new high dielectric constant materials and processes is increasing and becoming more and more critical as the size for current technology shrinks.

20 Standard dielectric materials like TiO_2 or new dielectric materials containing alkaline earth metals called strontium titanates, such as SrTiO_3 or Sr_2TiO_4 , or barium strontium titanates provide a significant advantage in capacitance compared to conventional dielectric materials. The new dielectric materials are also attractive candidates for several thin film applications, such as high dielectric constant materials for electronic devices, anti-reflection optical coatings, biocompatible coatings, photocatalysis, and solar cells. (H. A. Durand et al., Appl. Surf. Sci. 86, 122 (1995); C.-W. Wang et al., J. Appl. Phys. 91, 9198 (2002); M. Keshmiri et al., J. Non-Cryst. Solids 324, 289 (2003); T.

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Inoue et al., Nature (London) 277,637 (1979); H. Kim et al., Appl. Phys. Lett. 85, 64 (2004)).

In addition, TiO₂ is also a constituent of several important multi-metal oxide systems, such as strontium titanates (STOs), barium strontium titanates (BSTs), and lead zirconium titanates (PZTs), for dielectric and ferroelectric applications. (P. Alluri et al., Integr. Ferroelectr., 21, 305 (1998); J.F. Scott et al., Science 246, 1400 (1989)).

Nevertheless, deposition of Ti containing layers is difficult and new materials and processes are needed. For instance, atomic layer deposition, ALD, has been identified as an important thin film growth technique for microelectronics manufacturing, relying on sequential and saturating surface reactions of alternatively applied precursors, separated by inert gas purging. Frequently, an oxygen source such as ozone or water is used in this deposition method. The surface-controlled nature of ALD enables the growth of thin films of high conformality and uniformity with an accurate thickness control.

In STO ALD deposition, available Sr precursors show excellent reactivity with O₃ and acceptable reactivity with water. However, the use of ozone as an oxidant may have undesired results with the underlying layer, such as TiN or strontium ruthenium oxide (SRO), when the STO film is deposited at high temperature. It may either oxidize the TiN layer or partially etch Ru from SRO layer.

Although atomic layer deposition (ALD) of Ti compounds has been disclosed, these metal precursors have poor reactivity, especially with moisture, and low stability often requiring low substrate temperatures and strong oxidizers to grow a film, which is often contaminated with carbon or nitrogen.

Air Liquide showed that most of the standard homoleptic Ti molecules have limited ALD process temperature window or no deposition (R. Katamreddy, V. Omarjee, B. Feist, C. Dussarrat, ECS conference 2008). For example, in a water ALD process, the Ti molecules titanium tetrakis(isopropoxide) (TTIP), tetrakis(dimethylamino) titanium (TDMAT),

tetrakis(diethylamino) titanium (TDEAT), and tetrakis(ethylmethylanino) titanium (TEMAT) had deposition rates below 0.6 Å/cycle and process windows that did not exceed 250°C. Id.

New Ti precursors having higher thermal stability at higher process temperatures are needed. High temperature processes are desired to generate high quality TiO₂ (doped or undoped) and STO films with very high dielectric constants (preferably with $k \geq 50$). It has been reported that an STO film with a dense and columnar polycrystalline microstructure and a small average grain size (30 nm) is required to obtain a low leakage current with a high k value (C.S. Hwang, S.O. Park, C.S. Kang, H. Cho, H. Kang, S.T. Ahn, and M.Y. Lee, Jpn. J. Appl. Phys., Part 1, 34, 5178 1995).

Zhang et al. disclose the unexpected synthesis of Ti(Cy-NC(NiPr₂) N-Cy)₂(OnBu)₂. Chinese Science Bulletin (2005), 50(24), 2817-2820. Chen et al. disclose the synthesis of Ti(OnBu)₂(O₂CMe)₂. Huaxue Xuebao (2003), 61(10), 1592-1596. Uses for these compounds were not disclosed.

US Pat App Pub No 2005/277223 discloses ALD methods of forming metal oxides using metal-containing precursors having the formula M(L₁)_x(L₂)_y, wherein M is a metal, L₁ and L₂ may be halide, diketone, alkoxide, amino, alkoxyamine, amidinate, or multidentate ligands. The exemplary precursors however are only Hf(OtBu)₂(NEtMe)₂, Hf(OtBu)₂(NEt₂)₂, Hf(NEt₂)₂(DMAMP)₂, Hf(NEtMe)₂(DMAMP)₂, Ti(OtBu)₃Cl, Ti(OtBu)₃Me, Ti(OtBu)₂(NEt₂)₂, Ti(NEt₂)₂(DMAMP)₂, Ti(OtBu)₂(DMAMP)₂, and TiCl₂(DMAMP)₂.

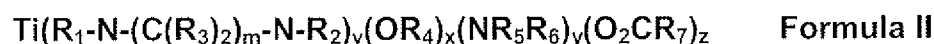
Other sources and methods of incorporating Ti materials are being sought for new generations of integrated circuit devices. Novel precursors are needed.

Summary

Disclosed are molecules having the following formula:



or



wherein:

- R_1 , R_2 , R_5 , R_6 , and R_7 are independently selected from the group consisting of H and C1-C6 alkyl group;

- R_3 = H, C1-C6 alkyl group, or NMe₂;

- R_4 is a C1-C6 alkyl group;

- m = 2-4;

- u = 0-2;

- v = 0-1;

- x = 1-3;

- y = 0-2;

- z = 0-1;

- in Formula I, $u+x+y+z = 4$;

- in Formula II, $2v+x+y+z = 4$; and

- u , v , or $z \geq 1$.

The disclosed molecules may further include one or more of the following aspects:

- the molecule having Formula I, wherein $u=1$, $x=3$, $y=0$, and $z=0$;

- the molecule being selected from the group consisting of Ti(iPr-N-C(Me)-N-iPr)₁(OiPr)₃, Ti(iPr-N-C(Me)-N-iPr)₁(OMe)₃, Ti(iPr-N-C(Me)-N-iPr)₁(OEt)₃, Ti(iPr-N-C(Me)-N-iPr)₁(OnPr)₃, Ti(iPr-N-C(Me)-N-iPr)₁(OsBu)₃, Ti(iPr-N-C(Me)-N-iPr)₁(OiBu)₃, Ti(iPr-N-C(Me)-N-iPr)₁(OtBu)₃, Ti(Et-N-C(Me)-N-Et)₁(OEt)₃, Ti(Et-N-C(Me)-N-Et)₁(OMe)₃, Ti(Et-N-C(Me)-N-Et)₁(OnPr)₃, Ti(Et-N-C(Me)-N-Et)₁(OsBu)₃, Ti(Et-N-C(Me)-N-Et)₁(OiBu)₃, Ti(Et-N-C(Me)-N-Et)₁(OtBu)₃, and Ti(iPr-N-C(NMe₂)-N-iPr)(OiPr)₃;

- the molecule having Formula II, wherein $v=1$, $x=2$, $y=0$, and $z=0$;

- The molecule being selected from the group consisting of Ti(iPr-N-(CH₂)₂-N-iPr)₁(OiPr)₂, Ti(iPr-N-(CH₂)₂-N-iPr)₁(OMe)₂, Ti(iPr-N-(CH₂)₂-N-iPr)₁(OEt)₂, Ti(iPr-N-(CH₂)₂-N-iPr)₁(OnPr)₂, Ti(iPr-N-(CH₂)₂-N-iPr)₁(OsBu)₂, Ti(iPr-N-(CH₂)₂-N-iPr)₁(OiBu)₂, Ti(iPr-N-(CH₂)₂-N-iPr)₁(OtBu)₂, Ti(Et-N-(CH₂)₂-N-Et)₁(OiPr)₂, Ti(Et-N-(CH₂)₂-N-Et)₁(OMe)₂, Ti(Et-N-(CH₂)₂-N-Et)₁(OEt)₂, Ti(Et-N-(CH₂)₂-N-Et)₁(OnPr)₂, Ti(Et-N-

(CH₂)₂-N-Et)₁(OsBu)₂, Ti(Et-N-(CH₂)₂-N-Et)₁(OiBu)₂, Ti(Et-N-(CH₂)₂-N-Et)₁(OtBu)₂, Ti(iPr-N-(CH₂)₃-N-iPr)₁(OiPr)₂, Ti(iPr-N-(CH₂)₃-N-iPr)₁(OMe)₂, Ti(iPr-N-(CH₂)₃-N-iPr)₁(OEt)₂, Ti(iPr-N-(CH₂)₃-N-iPr)₁(OnPr)₂, Ti(iPr-N-(CH₂)₃-N-iPr)₁(OsBu)₂, Ti(iPr-N-(CH₂)₃-N-iPr)₁(OiBu)₂, Ti(iPr-N-(CH₂)₃-N-iPr)₁(OtBu)₂, Ti(Et-N-(CH₂)₃-N-Et)₁(OiPr)₂, Ti(Et-N-(CH₂)₃-N-Et)₁(OMe)₂, Ti(Et-N-(CH₂)₃-N-Et)₁(OEt)₂, Ti(Et-N-(CH₂)₃-N-Et)₁(OnPr)₂, Ti(Et-N-(CH₂)₃-N-Et)₁(OsBu)₂, Ti(Et-N-(CH₂)₃-N-Et)₁(OiBu)₂, and Ti(Et-N-(CH₂)₃-N-Et)₁(OtBu)₂;

- the molecule having Formula I, wherein u=2, x=2, y=0, and z=0;

- the molecule being selected from the group consisting of Ti(iPr-N-C(H)-N-iPr)₂(OiPr)₂, Ti(iPr-N-C(H)-N-iPr)₂(OMe)₂, Ti(iPr-N-C(H)-N-iPr)₂(OEt)₂, Ti(iPr-N-C(H)-N-iPr)₂(OnPr)₂, Ti(iPr-N-C(H)-N-iPr)₂(OsBu)₂, Ti(iPr-N-C(H)-N-iPr)₂(OiBu)₂, Ti(iPr-N-C(H)-N-iPr)₂(OtBu)₂, Ti(Et-N-C(H)-N-Et)₂(OiPr)₂, Ti(Et-N-C(H)-N-Et)₂(OMe)₂, Ti(Et-N-C(H)-N-Et)₂(OEt)₂, Ti(Et-N-C(H)-N-Et)₂(OnPr)₂, Ti(Et-N-C(H)-N-Et)₂(OsBu)₂, Ti(Et-N-C(H)-N-Et)₂(OiBu)₂, Ti(Et-N-C(H)-N-Et)₂(OtBu)₂, Ti(iPr-N-C(Me)-N-iPr)₂(OiPr)₂, Ti(iPr-N-C(Me)-N-iPr)₂(OMe)₂, Ti(iPr-N-C(Me)-N-iPr)₂(OEt)₂, Ti(iPr-N-C(Me)-N-iPr)₂(OnPr)₂, Ti(iPr-N-C(Me)-N-iPr)₂(OsBu)₂, Ti(iPr-N-C(Me)-N-iPr)₂(OiBu)₂, Ti(iPr-N-C(Me)-N-iPr)₂(OtBu)₂, Ti(Et-N-C(Me)-N-Et)₂(OiPr)₂, Ti(Et-N-C(Me)-N-Et)₂(OMe)₂, Ti(Et-N-C(Me)-N-Et)₂(OEt)₂, Ti(Et-N-C(Me)-N-Et)₂(OnPr)₂, Ti(Et-N-C(Me)-N-Et)₂(OsBu)₂, Ti(Et-N-C(Me)-N-Et)₂(OiBu)₂, and Ti(Et-N-C(Me)-N-Et)₂(OtBu)₂;

- the molecule having Formula I, wherein u=1, x=2, y=1, and z=0;

- the molecule being selected from the group consisting of Ti(iPr-N-C(Me)-N-iPr)(OiPr)₂(NMe₂), Ti(iPr-N-C(Me)-N-iPr)(OiPr)₂(NEt₂), Ti(iPr-N-C(Me)-N-iPr)(OiPr)₂(NEtMe), Ti(Et-N-C(Me)-N-Et)(OiPr)₂(NMe₂), Ti(Et-N-C(Me)-N-Et)(OiPr)₂(NEt₂), Ti(Et-N-C(Me)-N-Et)(OiPr)₂(NEtMe), Ti(iPr-N-C(NMe₂)-N-iPr)(OiPr)₂(NMe₂), Ti(iPr-N-C(NMe₂)-N-iPr)(OiPr)₂(NEt₂), Ti(iPr-N-C(NMe₂)-N-iPr)(OiPr)₂(NEtMe), Ti(iPr-N-C(Me)-N-iPr)(OiPr)₂(NMeiPr), Ti(iPr-N-C(Me)-N-iPr)(OiPr)₂(NiPr₂), Ti(iPr-N-C(Me)-N-iPr)(OiPr)₂(NMe₂), Ti(iPr-N-C(Me)-N-

iPr)(OiPr)₂(NneoPentyl)₂, Ti(Et-N-C(Me)-N-Et)(OiPr)₂(NMeiPr), Ti(Et-N-C(Me)-N-Et)(OiPr)₂(NiPr₂), Ti(Et-N-C(Me)-N-Et)(OiPr)₂(NneoPentyl)₂, Ti(iPr-N-C(NMe₂)-N-iPr)(OiPr)₂(NMeiPr), Ti(iPr-N-C(NMe₂)-N-iPr)(OiPr)₂(NiPr₂), Ti(iPr-N-C(NMe₂)-N-iPr)(OiPr)₂(NneoPentyl)₂, and Ti(iPr-N-C(NMe₂)-N-iPr)(OiPr)₂(NMeiPr);

- the molecule having Formula I, wherein u=1, x=2, y=0, and z=1;
- the molecule being selected from the group consisting of Ti(iPr-N-C(Me)-N-iPr)(OiPr)₂(O₂CMe) and Ti(Et-N-C(Me)-N-Et)(OiPr)₂(O₂CMe);
- the molecule having Formula II, wherein v=1, x=1, y=0, and z=1;
- The molecule being selected from the group consisting of Ti(iPr-N-(CH₂)₂-N-iPr)(OiPr)(O₂CMe), Ti(iPr-N-(CH₂)₂-N-iPr)(OMe)(O₂CMe), Ti(iPr-N-(CH₂)₂-N-iPr)(OEt)(O₂CMe), Ti(iPr-N-(CH₂)₂-N-iPr)(OnPr)(O₂CMe), Ti(iPr-N-(CH₂)₂-N-iPr)(OsBu)(O₂CMe), Ti(iPr-N-(CH₂)₂-N-iPr)(OiBu)(O₂CMe), Ti(iPr-N-(CH₂)₂-N-iPr)(OtBu)(O₂CMe), Ti(Et-N-(CH₂)₂-N-Et)(OiPr)(O₂CMe), Ti(Et-N-(CH₂)₂-N-Et)(OMe)(O₂CMe), Ti(Et-N-(CH₂)₂-N-Et)(OEt)(O₂CMe), Ti(Et-N-(CH₂)₂-N-Et)(OnPr)(O₂CMe), Ti(Et-N-(CH₂)₂-N-Et)(OsBu)(O₂CMe), Ti(Et-N-(CH₂)₂-N-Et)(OiBu)(O₂CMe), and Ti(Et-N-(CH₂)₂-N-Et)(OtBu)(O₂CMe);
- the molecule having either Formula I or Formula II, wherein u, v, y=0, x=2, and z=2;
- the molecule being Ti(OiPr)₂(O₂CMe)₂;
- the molecule having either Formula I or Formula II, wherein u, v, y=0, x=3, and z=1; and
- the molecule being Ti(OiPr)₃(O₂CMe).

Also disclosed are methods of forming a Ti-containing layer on a substrate. A reaction chamber is provided having at least one substrate disposed within it. The vapor of at least one of the molecules disclosed above is introduced into the reaction chamber. The vapor is contacted with the substrate to form a Ti-containing layer on at least one surface of the substrate using a vapor deposition process. The disclosed methods may further include one or more of the following aspects:

- introducing into the reaction chamber a second vapor including at least one metal-containing precursor and contacting the second vapor with the substrate to form a metal-containing layer on at least one surface of the substrate using the vapor deposition process, wherein the metal-containing precursor is selected from the group consisting of $M(L)_2$ and $M(L)_2.A$, wherein:

- M is Sr or Ba;
- L is selected from substituted cyclopentadienyl ligand systems $R_1R_2R_3R_4R_5Cp$ or beta-diketonate ligand systems $-O-CR_6-CH-CR_7-O-$;
- each of R_1 to R_5 is independently selected from H or C1-C6 linear or branched alkyl chain;
- each of R_6 and R_7 is independently selected from C1-C6 linear or branched alkyl chain; and
- A is a neutral oxygen containing molecules selected from the group consisting of tetrahydrofuran, dimethoxyethane, diglyme, triglyme, and tetraglyme; and

- the metal-containing precursor being selected from the group consisting of $Sr(iPr_3Cp)_2$, $Sr(iPr_3Cp)_2.thf$, $Sr(iPr_3Cp)_2.dme$, $Sr(tBu_3Cp)_2$, $Sr(tBu_3Cp)_2.thf$, $Sr(tBu_3Cp)_2.dme$, $Sr(thmd)_2$, $Sr(thmd)_2.triglyme$, $Sr(thmd)_2.tetraglyme$, $Sr(Me_5Cp)_2$, $Sr(Me_4Cp)_2$, $Sr(Me_4EtCp)_2$, $Sr(Me_4nBuCp)_2$, $Ba(iPr_3Cp)_2$, $Ba(iPr_3Cp)_2.thf$, $Ba(iPr_3Cp)_2.dme$, $Ba(tBu_3Cp)_2$, $Ba(tBu_3Cp)_2.thf$, $Ba(tBu_3Cp)_2.dme$, $Ba(thmd)_2$, $Ba(thmd)_2.triglyme$, $Ba(thmd)_2.tetraglyme$, $Ba(Me_5Cp)_2$, $Ba(Me_4Cp)_2$, $Ba(Me_4EtCp)_2$, and $Ba(Me_4nBuCp)_2$.

Also disclosed are methods of depositing a STO or BST film. An ALD reaction chamber is provided having at least one substrate disposed within it. At least one of the compounds disclosed above is pulsed into the reaction chamber. An oxygen source is pulsed into the reaction chamber. A metal-containing precursor is pulsed into the reaction chamber. The metal-containing precursor is selected from the group consisting of $M(L)_2$ and $M(L)_2.A$, wherein:

- M is Sr or Ba;

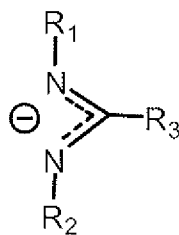
- L is selected from substituted cyclopentadienyl ligand systems $R_1R_2R_3R_4R_5Cp$ or beta-diketonate ligand systems $-O-CR_6-CH-CR_7-O-$;
- each of R_1 to R_5 is independently selected from H or C1-C6 linear or branched alkyl chain;
- each of R_6 and R_7 is independently selected from C1-C6 linear or branched alkyl chain; and
- A is a neutral oxygen containing molecules selected from the group consisting of tetrahydrofuran, dimethoxyethane, diglyme, triglyme, and tetraglyme.

A second oxygen source is pulsed into the reaction chamber. The stoichiometry of M:Ti ratio in the STO or BST film is controlled by varying the number of pulsing steps for the precursor and metal-containing precursor. The disclosed methods may further include one or more of the following aspects:

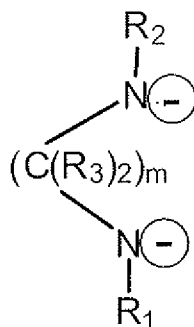
- the metal-containing precursor being selected from the group consisting of $Sr(iPr_3Cp)_2$, $Sr(iPr_3Cp)_2.thf$, $Sr(iPr_3Cp)_2.dme$, $Sr(tBu_3Cp)_2$, $Sr(tBu_3Cp)_2.thf$, $Sr(tBu_3Cp)_2.dme$, $Sr(thmd)_2$, $Sr(thmd)_2.triglyme$, $Sr(thmd)_2.tetraglyme$, $Sr(Me_5Cp)_2$, $Sr(Me_4Cp)_2$, $Sr(Me_4EtCp)_2$, $Sr(Me_4nBuCp)_2$, $Ba(iPr_3Cp)_2$, $Ba(iPr_3Cp)_2.thf$, $Ba(iPr_3Cp)_2.dme$, $Ba(tBu_3Cp)_2$, $Ba(tBu_3Cp)_2.thf$, $Ba(tBu_3Cp)_2.dme$, $Ba(thmd)_2$, $Ba(thmd)_2.triglyme$, $Ba(thmd)_2.tetraglyme$, $Ba(Me_5Cp)_2$, $Ba(Me_4Cp)_2$, $Ba(Me_4EtCp)_2$, and $Ba(Me_4nBuCp)_2$; and
- the oxygen source and the second oxygen source being water.

Notation and Nomenclature

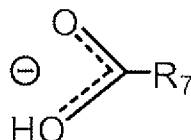
Certain abbreviations, symbols, and terms are used throughout the following description and claims and include: the abbreviation "STO" refers to strontium titanates; the abbreviation "BST" refers to barium strontium titanates; the abbreviation "PZT" refers to lead zirconium titanates; the abbreviation " $R_1-NC(R_3)N-R_2$ " refers to the following chemical structure:



the abbreviation " $R_1-N(C(R_3)_2)_m-N-R_2$ " refers to the following chemical structure:



the abbreviation " O_2CR_7 " refers to the following chemical structure:



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the abbreviation "Cy" refers to cyclohexyl; the abbreviation "Cp" refers to cyclopentadiene; the term "aliphatic group" refers to a C1-C6 linear or branched chain alkyl group; the term "alkyl group" refers to saturated functional groups containing exclusively carbon and hydrogen atoms and includes linear, branched, or cyclic alkyl groups. Examples of linear alkyl groups include without limitation, methyl groups, ethyl groups, n-propyl groups, n-butyl groups, etc. Examples of branched alkyls groups include without limitation, t-butyl. Examples of cyclic alkyl groups include without limitation, cyclopropyl groups, cyclobutyl groups, cyclopentyl groups, cyclohexyl groups, etc. The abbreviation "Me" refers to a methyl group; the abbreviation "Et" refers to an ethyl group; the abbreviation "Pr" refers to a propyl group; the abbreviation "iPr" refers to an isopropyl group; the abbreviation "iBu" refers to an isobutyl group; the abbreviation "nBu" refers to a n-butyl group; the abbreviation "sBu" refers to a sec-butyl group; the abbreviation "tBu" refers to a tertiary butyl group; the abbreviation "neo-pentyl" refers to $-CH_2CMe_3$; the abbreviation " N^Z -amd" refers to $R_1-NC(R_3)N-R_2$, wherein R_3 = a C1-C6 alkyl

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group and R_1 and $R_2 = Z$, which is defined as Me, Et, Pr, iPr, nBu, iBu, sBu, or tBu, for example N^{Me} -amd is Me-NC(Me)N-Me; the abbreviation " N^Z -fmd" refers to R_1 -NC(R_3)N- R_2 , wherein $R_3 = H$ and R_1 and $R_2 = Z$, which is defined as Me, Et, Pr, iPr, or tBu; the abbreviation " N^Z -gmd" refers to R_1 -NC(R_3)N- R_2 wherein $R_3 = NR_5R_6$ with R_5 and $R_6 = H$ or a C1-C6 alkyl group, and R_1 and $R_2 = Z$, which is defined as Me, Et, Pr, iPr, nBu, iBu, sBu, or tBu; the abbreviation "THF" refers to tetrahydrofuran; the abbreviation "TMA" refers to trimethyl aluminum; the abbreviation "ALD" refers to atomic layer deposition; the abbreviation "CVD" refers to chemical vapor deposition; the abbreviation "LPCVD" refers to low pressure chemical vapor deposition; the abbreviation "P-CVD" refers to pulsed chemical vapor deposition; the abbreviation "PE-ALD" refers to plasma enhanced atomic layer deposition; the abbreviation "MIM" refers to Metal Insulator Metal (a structure used in capacitors); the abbreviation "DRAM" refers to dynamic random access memory; the abbreviation "FeRAM" refers to ferroelectric random access memory; the abbreviation "CMOS" refers to complementary metal-oxide-semiconductor; the abbreviation "TGA" refers to thermogravimetric analysis.

The standard abbreviations of the elements from the periodic table of elements are used herein. It should be understood that elements may be referred to by these abbreviations (e.g., Ti refers to titanium, Ba refers to barium, etc.).

Brief Description of the Drawings

For a further understanding of the nature and objects of the present invention, reference should be made to the following detailed description, taken in conjunction with the accompanying drawings, in which like elements are given the same or analogous reference numbers and wherein:

FIG 1 is a thermogravimetric analysis (TGA) graph demonstrating the percentage of weight loss with temperature change for $Ti(N^{iPr}\text{-amd})(OiPr)_3$;

FIG 2 is a TGA graph for $Ti(N^{iPr}\text{-amd})_2(OiPr)_2$;

FIG 3 is a TGA graph for $Ti(N^{iPr}\text{-fmd})_2(OiPr)_2$;

FIG 4 is a TGA graph for $Ti(N^{iPr}\text{-amd})(OiPr)_2(NMe_2)$;

FIG 5 is a TGA graph for $\text{Ti}(\text{Et-N}-(\text{CH}_2)_2\text{-N-Et})(\text{OiPr})_2$; and

FIG 6 is a TGA graph for $\text{Ti}(\text{Me}_2\text{CH-N}-(\text{CH}_2)_3\text{-N-CHMe}_2)(\text{OiPr})_2$.

Description of Preferred Embodiments

5 Disclosed are novel titanium-containing precursors, methods of synthesizing the same, and methods of using the same.

The disclosed heteroleptic titanium-containing precursors are derived from different classes of ligand systems, such as amidinate, formamidinate, guanidinate, amide, and/or chelating amide ligands, plus alkoxide ligands.

10 Precursor design may help improve volatility, reduce the melting point (liquids or very low melting solids), increase reactivity with water, and increase thermal stability for wider process window applications.

The disclosed titanium-containing precursors have the following formulae:

15 $\text{Ti}(\text{R}_1\text{-N-C}(\text{R}_3)\text{-N-R}_2)_u(\text{OR}_4)_x(\text{NR}_5\text{R}_6)_y(\text{O}_2\text{CR}_7)_z$ **Formula I**

or

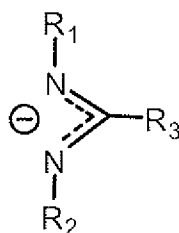
$\text{Ti}(\text{R}_1\text{-N-C}(\text{R}_3)_2)_m\text{-N-R}_2)_v(\text{OR}_4)_x(\text{NR}_5\text{R}_6)_y(\text{O}_2\text{CR}_7)_z$ **Formula II**

wherein:

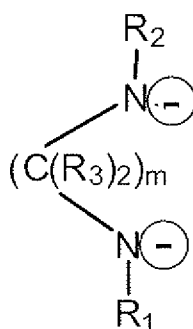
- R_1 , R_2 , R_5 , R_6 , and R_7 are independently selected from the group consisting of H and C1-C6 alkyl group;
- $\text{R}_3 = \text{H}$, C1-C6 alkyl group, or NMe_2 ;
- R_4 is a C1-C6 alkyl group;
- $m = 2-4$;
- $u = 0-2$;
- 25 ▪ $v = 0-1$;
- $x = 1-3$;
- $y = 0-2$;
- $z = 0-1$;
- in Formula I, $u+x+y+z = 4$;
- 30 ▪ in Formula II, $2v+x+y+z = 4$; and
- u , v , or $z \geq 1$.

As defined above, the C1-C6 alkyl group includes any linear, branched, or cyclic alkyl groups having from 1 to 6 carbon atoms, including but not limited to Me, tBu, or cyclohexyl groups.

In Formula I, the $R_1\text{-NC(R}_3\text{)N-R}_2$ ligand has the following chemical structure:

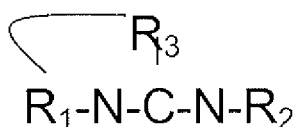


In Formula II, the $R_1\text{-N-(C(R}_3\text{)}_2\text{)}_m\text{-N-R}_2$ ligand has the following chemical structure:

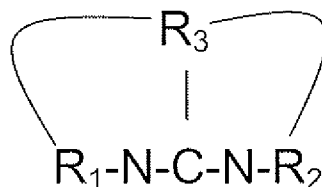


Therefore, although the same elements have been maintained in the backbone of the ligand (i.e., -N-C-N-), the ligand itself has gone from a -1 ligand having one delocalized negative charge between the -N-C-N- backbone to a -2 ligand having a negative charge localized at each nitrogen atom. Additionally, the Formula I ligand has a more rigid structure than the Formula II ligand.

When R_1 and R_3 are C1-C6 linear or branched alkyl groups in Formula I, R_1 and R_3 may be independent substituents or they may be linked together to form a monocyclic structure extending from R_1 to R_3 , as demonstrated below.



Similarly, when R_1 , R_3 and R_2 are C1-C6 linear or branched alkyl groups in Formula I, R_1 , R_3 and R_2 may be independent substituents or they may be linked together to form a bicyclic structure, as demonstrated below.



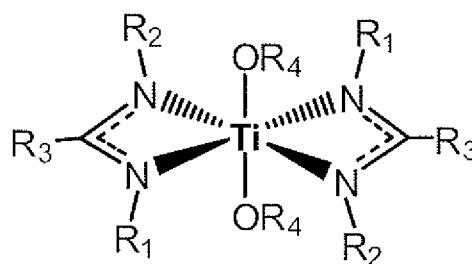
10 The configuration of the disclosed precursors was selected in order to optimize the reactivity (especially with H_2O) and, at the same time, the stability. The Ti-N bond is weak and will react rapidly on the surface. At the same time, the Ti-O bond is much stronger and will help stabilize the molecule to avoid fast decomposition. By tuning this molecule, a precursor is obtained that
15 reacts well on the substrate thanks to a weaker site

When $u=1$, $x=3$, $y=0$, and $z=0$ in Formula I, R_1 and R_2 are preferably Et or iPr, R_3 is preferably H, Me, or NMe_2 , and R_4 is preferably a C1-C4 linear or branched alkyl chain. Exemplary precursors include $Ti(iPr-N-C(H)-N-$
iPr)₁(OiPr)₃, $Ti(iPr-N-C(H)-N-iPr)_1(OMe)_3$, $Ti(iPr-N-C(H)-N-iPr)_1(OEt)_3$, $Ti(iPr-$
20 $N-C(H)-N-iPr)_1(OnPr)_3$, $Ti(iPr-N-C(H)-N-iPr)_1(OsBu)_3$, $Ti(iPr-N-C(H)-N-$
iPr)₁(OiBu)₃, $Ti(iPr-N-C(H)-N-iPr)_1(OtBu)_3$, $Ti(iPr-N-C(Me)-N-iPr)_1(OiPr)_3$,
 $Ti(iPr-N-C(Me)-N-iPr)_1(OMe)_3$, $Ti(iPr-N-C(Me)-N-iPr)_1(OEt)_3$, $Ti(iPr-N-C(Me)-$
N-iPr)₁(OnPr)₃, $Ti(iPr-N-C(Me)-N-iPr)_1(OsBu)_3$, $Ti(iPr-N-C(Me)-N-iPr)_1(OiBu)_3$,
 $Ti(iPr-N-C(Me)-N-iPr)_1(OtBu)_3$, $Ti(Et-N-C(Me)-N-Et)_1(OEt)_3$, $Ti(Et-N-C(Me)-N-$
25 $Et)_1(OMe)_3$, $Ti(Et-N-C(Me)-N-Et)_1(OnPr)_3$, $Ti(Et-N-C(Me)-N-Et)_1(OsBu)_3$, $Ti(Et-$
N-C(Me)-N-Et)₁(OiBu)₃, $Ti(Et-N-C(Me)-N-Et)_1(OtBu)_3$, or $Ti(iPr-N-C(NMe_2)-N-$
iPr)(OiPr)₃. The preferred exemplary precursor is $Ti(iPr-N-C(Me)-N-$
iPr)₁(OiPr)₃.

When $m=2$ or 3, $v=1$, $x=2$, $y=0$, and $z=0$ in Formula II, R_1 and R_2 are
30 preferably Et or iPr, R_3 is preferably H, and R_4 is preferably a C1-C4 linear or branched alkyl chain. More preferably, R_1 and R_2 are not Me when $m=2$. Exemplary precursors include $Ti(iPr-N-(CH_2)_2-N-iPr)_1(OiPr)_2$, $Ti(iPr-N-(CH_2)_2-$

$\text{N-iPr}_1(\text{OMe})_2$, $\text{Ti}(\text{iPr-N}-(\text{CH}_2)_2\text{-N-iPr})_1(\text{OEt})_2$, $\text{Ti}(\text{iPr-N}-(\text{CH}_2)_2\text{-N-iPr})_1(\text{OnPr})_2$,
 $\text{Ti}(\text{iPr-N}-(\text{CH}_2)_2\text{-N-iPr})_1(\text{OsBu})_2$, $\text{Ti}(\text{iPr-N}-(\text{CH}_2)_2\text{-N-iPr})_1(\text{OiBu})_2$, $\text{Ti}(\text{iPr-N}-(\text{CH}_2)_2\text{-N-iPr})_1(\text{OtBu})_2$, $\text{Ti}(\text{Et-N}-(\text{CH}_2)_2\text{-N-Et})_1(\text{OiPr})_2$, $\text{Ti}(\text{Et-N}-(\text{CH}_2)_2\text{-N-Et})_1(\text{OMe})_2$, $\text{Ti}(\text{Et-N}-(\text{CH}_2)_2\text{-N-Et})_1(\text{OEt})_2$, $\text{Ti}(\text{Et-N}-(\text{CH}_2)_2\text{-N-Et})_1(\text{OnPr})_2$, $\text{Ti}(\text{Et-N}-(\text{CH}_2)_2\text{-N-Et})_1(\text{OsBu})_2$, $\text{Ti}(\text{Et-N}-(\text{CH}_2)_2\text{-N-Et})_1(\text{OiBu})_2$, $\text{Ti}(\text{Et-N}-(\text{CH}_2)_2\text{-N-Et})_1(\text{OtBu})_2$, $\text{Ti}(\text{iPr-N}-(\text{CH}_2)_3\text{-N-iPr})_1(\text{OiPr})_2$, $\text{Ti}(\text{iPr-N}-(\text{CH}_2)_3\text{-N-iPr})_1(\text{OMe})_2$,
 $\text{Ti}(\text{iPr-N}-(\text{CH}_2)_3\text{-N-iPr})_1(\text{OEt})_2$, $\text{Ti}(\text{iPr-N}-(\text{CH}_2)_3\text{-N-iPr})_1(\text{OnPr})_2$, $\text{Ti}(\text{iPr-N}-(\text{CH}_2)_3\text{-N-iPr})_1(\text{OsBu})_2$, $\text{Ti}(\text{iPr-N}-(\text{CH}_2)_3\text{-N-iPr})_1(\text{OiBu})_2$, $\text{Ti}(\text{iPr-N}-(\text{CH}_2)_3\text{-N-iPr})_1(\text{OtBu})_2$,
 $\text{Ti}(\text{Et-N}-(\text{CH}_2)_3\text{-N-Et})_1(\text{OiPr})_2$, $\text{Ti}(\text{Et-N}-(\text{CH}_2)_3\text{-N-Et})_1(\text{OMe})_2$, $\text{Ti}(\text{Et-N}-(\text{CH}_2)_3\text{-N-Et})_1(\text{OEt})_2$, $\text{Ti}(\text{Et-N}-(\text{CH}_2)_3\text{-N-Et})_1(\text{OnPr})_2$, $\text{Ti}(\text{Et-N}-(\text{CH}_2)_3\text{-N-Et})_1(\text{OsBu})_2$, $\text{Ti}(\text{Et-N}-(\text{CH}_2)_3\text{-N-Et})_1(\text{OiBu})_2$, or $\text{Ti}(\text{Et-N}-(\text{CH}_2)_3\text{-N-Et})_1(\text{OtBu})_2$. The preferred
 exemplary precursors are $\text{Ti}(\text{iPr-N}-(\text{CH}_2)_2\text{-N-iPr})_1(\text{OiPr})_2$, $\text{Ti}(\text{Et-N}-(\text{CH}_2)_3\text{-N-Et})_1(\text{OiPr})_2$, or $\text{Ti}(\text{Et-N}-(\text{CH}_2)_2\text{-N-Et})_1(\text{OiPr})_2$.

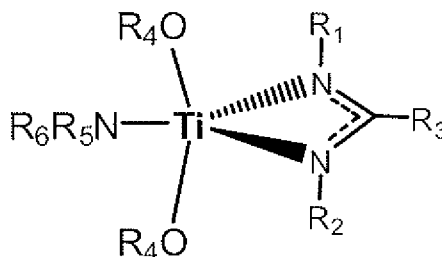
When $u=2$, $x=2$, $y=0$, and $z=0$ in Formula I, the precursor has the
 following chemical structure:



In this embodiment, R_1 and R_2 are preferably Et or iPr, R_3 is preferably H or Me, and R_4 is preferably a C1-C4 linear or branched alkyl chain. More preferably, R_3 is not NMe_2 . Exemplary precursors include $\text{Ti}(\text{iPr-N-C(H)-N-iPr})_2(\text{OiPr})_2$, $\text{Ti}(\text{iPr-N-C(H)-N-iPr})_2(\text{OMe})_2$, $\text{Ti}(\text{iPr-N-C(H)-N-iPr})_2(\text{OEt})_2$, $\text{Ti}(\text{iPr-N-C(H)-N-iPr})_2(\text{OnPr})_2$, $\text{Ti}(\text{iPr-N-C(H)-N-iPr})_2(\text{OsBu})_2$, $\text{Ti}(\text{iPr-N-C(H)-N-iPr})_2(\text{OiBu})_2$, $\text{Ti}(\text{iPr-N-C(H)-N-iPr})_2(\text{OtBu})_2$, $\text{Ti}(\text{Et-N-C(H)-N-Et})_2(\text{OiPr})_2$, $\text{Ti}(\text{Et-N-C(H)-N-Et})_2(\text{OMe})_2$, $\text{Ti}(\text{Et-N-C(H)-N-Et})_2(\text{OEt})_2$, $\text{Ti}(\text{Et-N-C(H)-N-Et})_2(\text{OnPr})_2$, $\text{Ti}(\text{Et-N-C(H)-N-Et})_2(\text{OsBu})_2$, $\text{Ti}(\text{Et-N-C(H)-N-Et})_2(\text{OiBu})_2$, $\text{Ti}(\text{Et-N-C(H)-N-Et})_2(\text{OtBu})_2$, $\text{Ti}(\text{iPr-N-C(Me)-N-iPr})_2(\text{OiPr})_2$, $\text{Ti}(\text{iPr-N-C(Me)-N-iPr})_2(\text{OMe})_2$, $\text{Ti}(\text{iPr-N-C(Me)-N-iPr})_2(\text{OEt})_2$, $\text{Ti}(\text{iPr-N-C(Me)-N-iPr})_2(\text{OnPr})_2$, $\text{Ti}(\text{iPr-N-C(Me)-N-iPr})_2(\text{OsBu})_2$, $\text{Ti}(\text{iPr-N-C(Me)-N-iPr})_2(\text{OiBu})_2$, $\text{Ti}(\text{iPr-N-C(Me)-N-iPr})_2(\text{OtBu})_2$, $\text{Ti}(\text{Et-N-C(Me)-N-Et})_2(\text{OiPr})_2$, $\text{Ti}(\text{Et-N-C(Me)-N-Et})_2(\text{OMe})_2$, $\text{Ti}(\text{Et-N-C(Me)-N-Et})_2(\text{OEt})_2$, $\text{Ti}(\text{Et-N-C(Me)-N-Et})_2(\text{OnPr})_2$, $\text{Ti}(\text{Et-N-C(Me)-N-Et})_2(\text{OsBu})_2$, $\text{Ti}(\text{Et-N-C(Me)-N-Et})_2(\text{OiBu})_2$, $\text{Ti}(\text{Et-N-C(Me)-N-Et})_2(\text{OtBu})_2$.

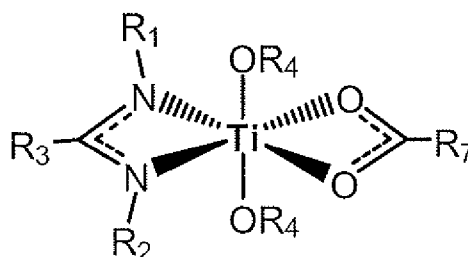
Et)₂(OEt)₂, Ti(Et-N-C(Me)-N-Et)₂(OnPr)₂, Ti(Et-N-C(Me)-N-Et)₂(OsBu)₂, Ti(Et-N-C(Me)-N-Et)₂(OiBu)₂, and Ti(Et-N-C(Me)-N-Et)₂(OtBu)₂. The preferred exemplary precursor is Ti(iPr-N-C(H)-N-iPr)₂(OiPr)₂ or Ti(iPr-N-C(Me)-N-iPr)₂(OiPr)₂.

When $u=1$, $x=2$, $y=1$, and $z=0$ in Formula I, the precursor has the following chemical structure:



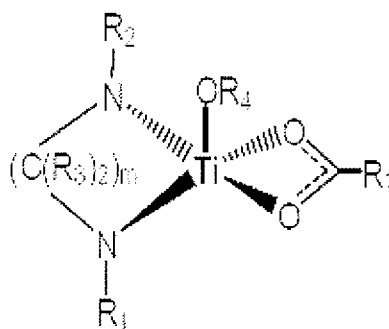
In this embodiment, R₁ and R₂ are preferably Et or iPr; R₃ is preferably H, Me, or NMe₂; R₄ is preferably iPr; and R₅ and R₆ preferably are independently Me or Et. Exemplary precursors include Ti(iPr-N-C(Me)-N-iPr)(OiPr)₂(NMe₂), Ti(iPr-N-C(Me)-N-iPr)(OiPr)₂(NEt₂), Ti(iPr-N-C(Me)-N-iPr)(OiPr)₂(NEtMe), Ti(Et-N-C(Me)-N-Et)(OiPr)₂(NMe₂), Ti(Et-N-C(Me)-N-Et)(OiPr)₂(NEt₂), Ti(Et-N-C(Me)-N-Et)(OiPr)₂(NEtMe), Ti(iPr-N-C(NMe₂)-N-iPr)(OiPr)₂(NMe₂), Ti(iPr-N-C(NMe₂)-N-iPr)(OiPr)₂(NEt₂), Ti(iPr-N-C(NMe₂)-N-iPr)(OiPr)₂(NEtMe), Ti(iPr-N-C(Me)-N-iPr)(OiPr)₂(NMeiPr), Ti(iPr-N-C(Me)-N-iPr)(OiPr)₂(NiPr₂), Ti(iPr-N-C(Me)-N-iPr)(OiPr)₂(NMeoPentyl), Ti(iPr-N-C(Me)-N-iPr)(OiPr)₂(NneoPentyl), Ti(Et-N-C(Me)-N-Et)(OiPr)₂(NMeiPr), Ti(Et-N-C(Me)-N-Et)(OiPr)₂(NiPr₂), Ti(Et-N-C(Me)-N-Et)(OiPr)₂(NneoPentyl), Ti(iPr-N-C(NMe₂)-N-iPr)(OiPr)₂(NMeiPr), Ti(iPr-N-C(NMe₂)-N-iPr)(OiPr)₂(NiPr₂), Ti(iPr-N-C(NMe₂)-N-iPr)(OiPr)₂(NneoPentyl), and Ti(iPr-N-C(NMe₂)-N-iPr)(OiPr)₂(NMeiPr). The preferred exemplary precursor is Ti(iPr-N-C(Me)-N-iPr)(OiPr)₂(NMe₂).

When $u=1$, $x=2$, $y=0$, and $z=1$ in Formula I, the precursor has the following chemical structure:

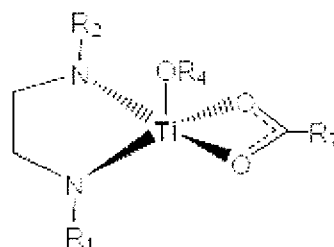


In this embodiment, R_1 and R_2 are preferably Et or iPr; R_3 is preferably H or Me; R_4 is preferably iPr; and R_7 is preferably Me. Exemplary precursors include $\text{Ti}(\text{iPr-N-C}(\text{Me})\text{-N-iPr})(\text{OiPr})_2(\text{O}_2\text{CMe})$ and $\text{Ti}(\text{Et-N-C}(\text{Me})\text{-N-Et})(\text{OiPr})_2(\text{O}_2\text{CMe})$.

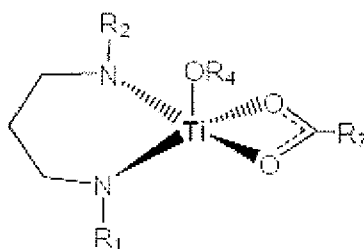
When $v = 1$, $x = 1$, $y=0$, and $z = 1$ in Formula II, the precursor has the following chemical structure:



When $m=2$, $v=1$, $x=1$, $y=0$, $z=1$, and $R_3=\text{H}$, the precursor has the following chemical structure:



When $m=3$, $v=1$, $x=1$, $y=0$, $z=1$, and $R_3=\text{H}$, the precursor has the following chemical structure:



In these embodiments, *m* is preferably 2 or 3, *R*₁ and *R*₂ are preferably Et or *i*Pr; *R*₃ is preferably H; *R*₄ is preferably a C1-C4 linear or branched alkyl chain; and *R*₇ is preferably Me. Exemplary precursors include Ti(*i*Pr-N-(CH₂)₂-*i*Pr)(*Oi*Pr)(O₂CMe), Ti(*i*Pr-N-(CH₂)₂-N-*i*Pr)(OMe)(O₂CMe), Ti(*i*Pr-N-(CH₂)₂-N-*i*Pr)(OEt)(O₂CMe), Ti(*i*Pr-N-(CH₂)₂-N-*i*Pr)(OnPr)(O₂CMe), Ti(*i*Pr-N-(CH₂)₂-N-*i*Pr)(OsBu)(O₂CMe), Ti(*i*Pr-N-(CH₂)₂-N-*i*Pr)(*Oi*Bu)(O₂CMe), Ti(*i*Pr-N-(CH₂)₂-N-*i*Pr)(OtBu)(O₂CMe), Ti(Et-N-(CH₂)₂-N-Et)(*Oi*Pr)(O₂CMe), Ti(Et-N-(CH₂)₂-N-Et)(OMe)(O₂CMe), Ti(Et-N-(CH₂)₂-N-Et)(OEt)(O₂CMe), Ti(Et-N-(CH₂)₂-N-Et)(OnPr)(O₂CMe), Ti(Et-N-(CH₂)₂-N-Et)(OsBu)(O₂CMe), Ti(Et-N-(CH₂)₂-N-Et)(*Oi*Bu)(O₂CMe), and Ti(Et-N-(CH₂)₂-N-Et)(OtBu)(O₂CMe).

When *u*=1, *x*=1, *y*=2, and *z*=0 in Formula I, exemplary precursors include Ti(*i*Pr-N-C(Me)-N-*i*Pr)(*Oi*Pr)(NMe₂)₂, Ti(*i*Pr-N-C(Me)-N-*i*Pr)(*Oi*Pr)(NEt₂)₂, Ti(*i*Pr-N-C(Me)-N-*i*Pr)(*Oi*Pr)(NEtMe)₂, Ti(Et-N-C(Me)-N-Et)(*Oi*Pr)(NMe₂)₂, Ti(Et-N-C(Me)-N-Et)(*Oi*Pr)(NEt₂)₂, Ti(Et-N-C(Me)-N-Et)(*Oi*Pr)(NEtMe)₂, Ti(*i*Pr-N-C(NMe₂)-N-*i*Pr)(*Oi*Pr)(NMe₂)₂, Ti(*i*Pr-N-C(NMe₂)-N-*i*Pr)(*Oi*Pr)(NEt₂)₂, and Ti(*i*Pr-N-C(NMe₂)-N-*i*Pr)(*Oi*Pr)(NEtMe)₂.

When *v*=1, *x*=1, *y*=1, and *z*=0 in Formula II, exemplary precursors include Ti(*i*Pr-N-(CH₂)₂-N-*i*Pr)(*Oi*Pr)(NMe₂), Ti(*i*Pr-N-(CH₂)₂-N-*i*Pr)(*Oi*Pr)(NEt₂), Ti(*i*Pr-N-(CH₂)₂-N-*i*Pr)(*Oi*Pr)(NEtMe), Ti(Et-N-(CH₂)₂-N-Et)(*Oi*Pr)(NMe₂), Ti(Et-N-(CH₂)₂-N-Et)(*Oi*Pr)(NEt₂), and Ti(Et-N-(CH₂)₂-N-Et)(*Oi*Pr)(NEtMe).

When *u*=1, *x*=1, *y*=0, and *z*=2 in Formula I, exemplary precursors include Ti(*i*Pr-N-C(Me)-N-*i*Pr)(*Oi*Pr)(O₂CMe)₂ and Ti(Et-N-C(Me)-N-Et)(*Oi*Pr)(O₂CMe)₂.

When *u*, *v*, *y*=0, *x*=2, and *z*=2 in either of Formula I or Formula II, exemplary precursors include Ti(*Oi*Pr)₂(O₂CMe)₂.

When $u, v, y=0, x=3$, and $z=1$ in either of Formula I or Formula II, exemplary precursors include $Ti(OiPr)_3(O_2CMe)$.

The disclosed precursors may be synthesized by combining a hydrocarbon solution of $H(R_1-N-C(R_3)-N-R_2)$ with a neat or hydrocarbon
5 solution of a titanium compound, such as $Ti(OR_4)_3(NR_5R_6)$ or $Ti(OR_4)_2(NR_5R_6)_2$, under atmosphere of nitrogen, the outlet of the mixing flask being connected to an oil bubbler. Exemplary hydrocarbon solutions include pentane. The resulting solution is stirred at room temperature overnight. Where applicable, HO_2CR_7 may be added and further stirred for 6-12 hours. Solvent and volatiles
10 are removed from the reaction mixture under vacuum. Purification of the resulting liquid or solid is carried out by distillation or sublimation, respectively. Additional synthesis details are provided in the Examples.

Also disclosed are methods of using the disclosed titanium-containing precursors for vapor deposition methods. The disclosed methods provide for
15 the use of the titanium-containing precursors for deposition of titanium-containing films. The disclosed methods may be useful in the manufacture of semiconductor, photovoltaic, LCD-TFT, or flat panel type devices. The method includes: providing a substrate; providing a vapor including at least one of the disclosed titanium-containing precursors; and contacting the vapor
20 with the substrate (and typically directing the vapor to the substrate) to form a titanium-containing layer on at least one surface of the substrate.

The disclosed methods also provide for forming a bimetal-containing layer on a substrate using a vapor deposition process and, more particularly, for deposition of STO or BST films. The disclosed methods may be useful in
25 the manufacture of semiconductor, photovoltaic, LCD-TFT, or flat panel type devices. The method includes: providing a substrate; providing a vapor including at least one of the disclosed titanium-containing precursors and contacting the vapor with the substrate (and typically directing the vapor to the substrate) to form a bi metal-containing layer on at least one surface of the
30 substrate. An oxygen source, such as O_3, O_2, H_2O , and NO , preferably H_2O , may also be provided with the vapor.

The disclosed titanium-containing precursors may be used to deposit titanium-containing films using any deposition methods known to those of skill in the art. Examples of suitable deposition methods include without limitation, conventional chemical vapor deposition (CVD), low pressure chemical vapor deposition (LPCVD), atomic layer deposition (ALD), pulsed chemical vapor deposition (P-CVD), plasma enhanced atomic layer deposition (PE-ALD), or combinations thereof. Preferably, the deposition method is ALD or PE-ALD.

The vapor of the titanium-containing precursor is introduced into a reaction chamber containing at least one substrate. The temperature and the pressure within the reaction chamber and the temperature of the substrate are held at suitable conditions so that contact between the titanium-containing precursor and substrate results in formation of a Ti-containing layer on at least one surface of the substrate. A reactant may also be used to help in formation of the Ti-containing layer.

The reaction chamber may be any enclosure or chamber of a device in which deposition methods take place, such as, without limitation, a parallel-plate type reactor, a cold-wall type reactor, a hot-wall type reactor, a single-wafer reactor, a multi-wafer reactor, or other such types of deposition systems. All of these exemplary reaction chambers are capable of serving as an ALD reaction chamber. The reaction chamber may be maintained at a pressure ranging from about 0.5 mTorr (0.07 Pa) to about 20 Torr (2700 Pa). In addition, the temperature within the reaction chamber may range from about 200°C to about 600°C. One of ordinary skill in the art will recognize that the temperature may be optimized through mere experimentation to achieve the desired result.

The temperature of the reaction chamber may be controlled by either controlling the temperature of the substrate holder or controlling the temperature of the reactor wall. Devices used to heat the substrate are known in the art. The reactor wall is heated to a sufficient temperature to obtain the desired film at a sufficient growth rate and with desired physical state and composition. A non-limiting exemplary temperature range to which the reactor wall may be heated includes from approximately 200°C to

approximately 600°C. When a plasma deposition process is utilized, the deposition temperature may range from approximately 200°C to approximately 550°C. Alternatively, when a thermal process is performed, the deposition temperature may range from approximately 400°C to approximately 600°C.

Alternatively, the substrate may be heated to a sufficient temperature to obtain the desired titanium-containing film at a sufficient growth rate and with desired physical state and composition. A non-limiting exemplary temperature range to which the substrate may be heated includes from 150°C to 600°C. Preferably, the temperature of the substrate remains less than or equal to 450°C.

The type of substrate upon which the titanium-containing film will be deposited will vary depending on the final use intended. In some embodiments, the substrate may be chosen from oxides which are used as dielectric materials in MIM, DRAM, or FeRam technologies (for example, HfO₂ based materials, TiO₂ based materials, ZrO₂ based materials, rare earth oxide based materials, ternary oxide based materials, etc.) or from nitride-based films (for example, TaN) that are used as an oxygen barrier between copper and the low-k layer. Other substrates may be used in the manufacture of semiconductors, photovoltaics, LCD-TFT, or flat panel devices. Examples of such substrates include, but are not limited to, solid substrates such as metal nitride containing substrates (for example, TaN, TiN, WN, TaCN, TiCN, TaSiN, and TiSiN); insulators (for example, SiO₂, Si₃N₄, SiON, HfO₂, Ta₂O₅, ZrO₂, TiO₂, Al₂O₃, and barium strontium titanate); or other substrates that include any number of combinations of these materials. The actual substrate utilized may also depend upon the specific precursor embodiment utilized. In many instances though, the preferred substrate utilized will be selected from TiN, SRO, Ru, and Si type substrates.

The titanium-containing precursor may be fed in liquid state to a vaporizer where it is vaporized before it is introduced into the reaction chamber. Prior to its vaporization, the titanium-containing precursor may optionally be mixed with one or more solvents, one or more metal sources,

and a mixture of one or more solvents and one or more metal sources. The solvents may be selected from the group consisting of toluene, ethyl benzene, xylene, mesitylene, decane, dodecane, octane, hexane, pentane, or others. The resulting concentration may range from approximately 0.05 M to approximately 2 M. The metal source may include any metal-containing precursors now known or later developed.

Alternatively, the titanium-containing precursor may be vaporized by passing a carrier gas into a container containing the titanium-containing precursor or by bubbling the carrier gas into the titanium-containing precursor. The carrier gas and titanium-containing precursor are then introduced into the reaction chamber as a vapor. The carrier gas may include, but is not limited to, Ar, He, N₂, and mixtures thereof. The titanium-containing precursor may optionally be mixed in the container with one or more solvents, metal-containing precursors, or mixtures thereof. If necessary, the container may be heated to a temperature that permits the titanium-containing precursor to be in its liquid phase and to have a sufficient vapor pressure. The container may be maintained at temperatures in the range of, for example, approximately 0°C to approximately 150°C. Those skilled in the art recognize that the temperature of the container may be adjusted in a known manner to control the amount of titanium-containing precursor vaporized.

In addition to the optional mixing of the titanium-containing precursor with solvents, metal-containing precursors, and stabilizers prior to introduction into the reaction chamber, the titanium-containing precursor may be mixed with reactants inside the reaction chamber. Exemplary reactants include, without limitation, metal-containing precursors such as strontium-containing precursors, barium-containing precursors, aluminum-containing precursors such as TMA, and any combination thereof. These or other metal-containing precursors may be incorporated into the resultant film in small quantities, as a dopant, or as a second or third metal in the resulting film, such as BST and STO.

When the desired titanium-containing film also contains oxygen, such as, for example and without limitation, STO, the reactants may include an

oxygen source which is selected from, but not limited to, O_2 , O_3 , H_2O , H_2O_2 , acetic acid, formalin, para-formaldehyde, and combinations thereof. Preferably, when an ALD process is performed, the reactant is H_2O .

The reactant may be treated by plasma in order to decompose the reactant into its radical form. The plasma may be generated or present within the reaction chamber itself. Alternatively, the plasma may generally be at a location removed from the reaction chamber, for instance, in a remotely located plasma system. One of skill in the art will recognize methods and apparatus suitable for such plasma treatment.

For example, the reactant may be introduced into a direct plasma reactor, which generates a plasma in the reaction chamber, to produce the plasma-treated reactant in the reaction chamber. Exemplary direct plasma reactors include the Titan™ PECVD System produced by Trion Technologies. The reactant may be introduced and held in the reaction chamber prior to plasma processing. Alternatively, the plasma processing may occur simultaneously with the introduction of reactant. In-situ plasma is typically a 13.56 MHz RF capacitively coupled plasma that is generated between the showerhead and the substrate holder. The substrate or the showerhead may be the powered electrode depending on whether positive ion impact occurs. Typical applied powers in in-situ plasma generators are from approximately 100 W to approximately 1000 W. The disassociation of the reactant using in-situ plasma is typically less than achieved using a remote plasma source for the same power input and is therefore not as efficient in reactant disassociation as a remote plasma system, which may be beneficial for the deposition of metal-nitride-containing films on substrates easily damaged by plasma.

Alternatively, the plasma-treated reactant may be produced outside of the reaction chamber. The MKS Instruments' ASTRON®i reactive gas generator may be used to treat the reactant prior to passage into the reaction chamber. Operated at 2.45 GHz, 7kW plasma power, and a pressure ranging from approximately 3 Torr to approximately 10 Torr, the reactant O_3 may be decomposed into three $O^\cdot$ radicals. Preferably, the remote plasma may be

generated with a power ranging from about 1 kW to about 10 kW, more preferably from about 2.5 kW to about 7.5 kW.

When the desired titanium-containing film also contains another metal, such as, for example and without limitation, Ta, Hf, Zr, Nb, Mg, Al, Sr, Y, Ba, Ca, As, Sb, Bi, Sn, Pb, Co, lanthanides (such as Eu), or combinations thereof, the reactants may include a metal-containing precursor which is selected from, but not limited to, metal alkyls, such as $\text{Ln}(\text{RCp})_3$ or $\text{Co}(\text{RCp})_2$, metal amines, such as $\text{Zr}(\text{Cp})(\text{NMe}_2)_3$ or $\text{Hf}(\text{Cp})(\text{NMe}_2)_3$, and any combination thereof.

In one preferred embodiment, the reactant may be a metal-containing precursor compound having the formula $\text{M}(\text{L})_2$ or $\text{M}(\text{L})_2\text{A}$, wherein M is Sr or Ba, L is selected from (a) substituted cyclopentadienyl ligand systems ($\text{R}_1\text{R}_2\text{R}_3\text{R}_4\text{R}_5\text{Cp}$) in which each of R_1 to R_5 is independently selected from H or C1-C6 linear or branched alkyl chains, or (b) beta-diketonate ligand systems ($-\text{O}-\text{CR}_6-\text{CH}-\text{CR}_7-\text{O}-$), in which each of R_6 and R_7 is independently selected from C1-C6 linear or branched alkyl chain; and A = is a neutral oxygen containing molecule, including but not limited to tetrahydrofuran, dimethoxyethane, diglyme, triglyme, tetraglyme, or a combination thereof. Preferably, the metal-containing precursor has the formula $\text{M}(\text{R}_5\text{Cp})_2$ with each R being independently selected from H, Me, Et, and nBu.

Exemplary metal-containing precursors include but are not limited to $\text{Sr}(\text{iPr}_3\text{Cp})_2$, $\text{Sr}(\text{iPr}_3\text{Cp})_2\cdot\text{thf}$, $\text{Sr}(\text{iPr}_3\text{Cp})_2\cdot\text{dme}$, $\text{Sr}(\text{tBu}_3\text{Cp})_2$, $\text{Sr}(\text{tBu}_3\text{Cp})_2\cdot\text{thf}$, $\text{Sr}(\text{tBu}_3\text{Cp})_2\cdot\text{dme}$, $\text{Sr}(\text{thmd})_2$, $\text{Sr}(\text{thmd})_2\cdot\text{triglyme}$, $\text{Sr}(\text{thmd})_2\cdot\text{tetraglyme}$, $\text{Sr}(\text{Me}_5\text{Cp})_2$, $\text{Sr}(\text{Me}_4\text{Cp})_2$, $\text{Sr}(\text{Me}_4\text{EtCp})_2$, $\text{Sr}(\text{Me}_4\text{nBuCp})_2$, $\text{Ba}(\text{iPr}_3\text{Cp})_2$, $\text{Ba}(\text{iPr}_3\text{Cp})_2\cdot\text{thf}$, $\text{Ba}(\text{iPr}_3\text{Cp})_2\cdot\text{dme}$, $\text{Ba}(\text{tBu}_3\text{Cp})_2$, $\text{Ba}(\text{tBu}_3\text{Cp})_2\cdot\text{thf}$, $\text{Ba}(\text{tBu}_3\text{Cp})_2\cdot\text{dme}$, $\text{Ba}(\text{thmd})_2$, $\text{Ba}(\text{thmd})_2\cdot\text{triglyme}$, $\text{Ba}(\text{thmd})_2\cdot\text{tetraglyme}$, $\text{Ba}(\text{Me}_5\text{Cp})_2$, $\text{Ba}(\text{Me}_4\text{Cp})_2$, $\text{Ba}(\text{Me}_4\text{EtCp})_2$, and $\text{Ba}(\text{Me}_4\text{nBuCp})_2$.

The vapor of the metal-containing precursor (i.e., second vapor) is introduced into a reaction chamber. The temperature and the pressure within the reaction chamber and the temperature of the substrate are held at suitable conditions so that contact between the metal-containing precursor and substrate results in formation of a M-containing layer on at least one surface

of the substrate. A reactant may also be used to help in formation of the M-containing layer.

One of ordinary skill in the art will recognize that additional reactants may be used in the disclosed deposition processes. The term "second vapor" is merely used to avoid confusion with the "vapor" of the titanium-containing precursor. For example, a second vapor of a metal-containing precursor having the formula $\text{Sr}(\text{iPr}_3\text{Cp})_2$ and a third vapor of a metal-containing precursor having the formula $\text{Ba}(\text{Me}_5\text{Cp})_2$ may be used with the vapor of the disclosed titanium-containing precursors to form a BST film.

The titanium-containing precursor and one or more reactants may be introduced into the reaction chamber simultaneously (chemical vapor deposition), sequentially (atomic layer deposition), or in other combinations. For example, the titanium-containing precursor may be introduced in one pulse and two additional metal sources may be introduced together in a separate pulse [modified atomic layer deposition]. Alternatively, the reaction chamber may already contain the reactant prior to introduction of the titanium-containing precursor. The reactant may be passed through a plasma system localized remotely from the reaction chamber, and decomposed to radicals.

Alternatively, the titanium-containing precursor may be introduced to the reaction chamber continuously while other metal sources are introduced by pulse (pulsed-chemical vapor deposition). In each example, a pulse may be followed by a purge or evacuation step to remove excess amounts of the component introduced. In each example, the pulse may last for a time period ranging from about 0.01 s to about 10 s, alternatively from about 0.3 s to about 3 s, alternatively from about 0.5 s to about 2 s.

In one non-limiting exemplary atomic layer deposition type process, the vapor phase of a titanium-containing precursor is introduced into the reaction chamber, where it is contacted with a suitable substrate. Excess titanium-containing precursor may then be removed from the reaction chamber by purging and/or evacuating the reaction chamber. An oxygen source is introduced into the reaction chamber where it reacts with the absorbed titanium precursor in a self-limiting manner. Any excess oxygen source is removed from

the reaction chamber by purging and/or evacuating the reaction chamber. If the desired film is a titanium oxide film, this two-step process may provide the desired film thickness or may be repeated until a film having the necessary thickness has been obtained.

5 Alternatively, if the desired film is a titanium metal oxide film (i.e., TiMO), the two-step process above may be followed by introduction of a second vapor of a metal-containing precursor into the reaction chamber. The metal-containing precursor will be selected based on the nature of the titanium metal oxide film being deposited. After introduction into the reaction chamber, the
10 metal-containing precursor is contacted with the substrate. Any excess metal-containing precursor is removed from the reaction chamber by purging and/or evacuating the reaction chamber. Once again, an oxygen source may be introduced into the reaction chamber to react with the metal-containing precursor. Excess oxygen source is removed from the reaction chamber by
15 purging and/or evacuating the reaction chamber. If a desired film thickness has been achieved, the process may be terminated. However, if a thicker film is desired, the entire four-step process may be repeated. By alternating the provision of the titanium-containing precursor, metal-containing precursor, and oxygen source, a film of desired composition and thickness can be deposited.

20 Additionally, by varying the number of pulses, films having a desired stoichiometric M:Ti ratio may be obtained. For example, a Sr_2TiO_4 film may be obtained by having one pulse of the titanium-containing precursor and two pulses of the metal-containing precursor, with each pulse being followed by pulses of the oxygen source. However, one of ordinary skill in the art will
25 recognize that the number of pulses required to obtain the desired film may not be identical to the stoichiometric ratio of the resulting film.

 The titanium-containing films or titanium-containing layers resulting from the processes discussed above may include STO, BST, or PZT. One of ordinary skill in the art will recognize that by judicious selection of the appropriate
30 titanium-containing precursor and reactants, the desired film composition may be obtained.

Examples

The following non-limiting examples are provided to further illustrate embodiments of the invention. However, the examples are not intended to be all inclusive and are not intended to limit the scope of the inventions described herein.

Example 1

Ti(N^{iPr}-amd)(OiPr)₃: A 200 mL pentane solution was chilled to -30°C for 1h, followed by addition of 10.0g, 37.15 mmol, of Ti(OiPr)₃(NMe₂) and stirring at room temperature under atmosphere of nitrogen. A solution of N^{iPr}-amd-H (5.28g, 37.15 mmol) in 20 mL of pentane was added slowly to the above mixture. The outlet of the flask was connected to an oil bubbler, which in turn was connected to an acid scrubber. The resulting solution was stirred at room temperature overnight. Solvent and volatiles were removed from the reaction mixture under vacuum, resulting in an orange liquid. Purification of the orange liquid by distillation gave 12.5g (92%). **FIG 1** is a TGA graph demonstrating the percentage of weight loss with temperature change for this precursor. NMR (C₆D₆, δ): 1.17 (12H, d, (CH₃)₂-CH-N-C(CH₃)=N-CH-(CH₃)₂), 1.23 (18H, d, O-CH-(CH₃)₂), 1.86 (3H, s, (CH₃)₂-CH-N-C(CH₃)=N-CH-(CH₃)₂), 3.57 (1H, m, O-CH-(CH₃)₂), 4.46 (2H, m, O-CH-(CH₃)₂), 4.73 (2H, m, (CH₃)₂-CH-N-C(H)=N-CH-(CH₃)₂).

Example 2

Ti(N^{iPr}-amd)₂(OiPr)₂: To a pentane solution containing 11.19g, 78.68 mmol, of N^{iPr}-amd-H stirring at room temperature was added slowly a neat Ti(OiPr)₂(NMe₂)₂ (10.00 g, 39.34 mmol) compound under atmosphere of nitrogen, the outlet of the flask connected to an oil bubbler. The resulting solution was stirred at room temperature overnight. Solvent and volatiles were removed from the reaction mixture under vacuum. A dark orange-red solid was obtained. Purification of the solid was carried out by sublimation, resulting in yield: 15.4g, 88%. **FIG 2** is a TGA graph demonstrating the percentage of weight loss with temperature change for this precursor.

NMR (C_6D_6 , δ): 1.14 (6H, br, $(CH_3)_2-CH-N-C(CH_3)=N-CH-(CH_3)_2$), 1.31 (24H, br, $(CH_3)_2-CH-N-C(H)=N-CH-(CH_3)_2$), 1.53 (12H, d, $O-CH-(CH_3)_2$), 3.56 (4H, br, $(CH_3)_2-CH-N-C(H)=N-CH-(CH_3)_2$), 4.85 (2H, d, $O-CH-(CH_3)_2$).

5 Example 3

Ti(N^{iPr} -fmd) $_2$ (OiPr) $_2$: To a pentane solution containing 10.00g, 78.68 mmol, of N^{iPr} -fmd-H stirring at room temperature was added slowly a neat Ti(OiPr) $_2$ (NMe $_2$) $_2$ (10.00 g, 39.34 mmol) compound under atmosphere of nitrogen, the outlet of the flask connected to an oil bubbler. The resulting
10 solution was stirred at room temperature overnight. Solvent and volatiles were removed from the reaction mixture under vacuum. A yellow orange solid was obtained. Purification of the solid was carried out by sublimation, resulting in yield: 16.5g, 74%. **FIG 3** is a TGA graph demonstrating the percentage of weight loss with temperature change for this precursor.

15 NMR (C_6D_6 , δ): 1.27 (24H, br, $(CH_3)_2-CH-N-C(H)=N-CH-(CH_3)_2$), 1.29 (12H, d, $O-CH-(CH_3)_2$), 3.99 (4H, br, $(CH_3)_2-CH-N-C(H)=N-CH-(CH_3)_2$), 4.88 (2H, d, $O-CH-(CH_3)_2$), 7.88 (2H, br, $(CH_3)_2-CH-N-C(H)=N-CH-(CH_3)_2$).

20 Example 4

Ti(N^{iPr} -gmd) $_2$ (OiPr) $_2$: To a pentane solution containing 2.98 g, 23.60 mmol, of $iPr-N=C=N-iPr$ stirring at room temperature was added slowly a neat Ti(OiPr) $_2$ (NMe $_2$) $_2$ (3.00 g, 11.80 mmol) compound under atmosphere of nitrogen, the outlet of the flask connected to an oil bubbler. The resulting
25 solution was stirred at room temperature overnight. Solvent and volatiles were removed from the reaction mixture under vacuum. A red solid was obtained. Purification of the solid was carried out by sublimation, resulting in very low yield, NMR spectra showed a mixture of products.

30 Example 5

Ti(N^{iPr} -amd)(OiPr) $_2$ (NMe $_2$): To an 80 mL pentane solution containing 14.3g, 56.31 mmol of Ti(OiPr) $_2$ (NMe $_2$) $_2$ stirring at room temperature under atmosphere of nitrogen was added slowly drop wise a solution of N^{iPr} -amd-H

(8.01g, 56.31 mmol) in 50 mL pentane. The outlet of the flask connected to an oil bubbler, which in turn was connected to an acid scrubber. The resulting solution was stirred at room temperature overnight. Solvent and volatiles were removed from the reaction mixture under vacuum, resulting in an orange red liquid. Purification of orange red liquid by distillation gave 11.5g (60%). **FIG 4** is a TGA graph demonstrating the percentage of weight loss with temperature change for this precursor. NMR (C_6D_6 , δ): 1.14 (12H, d, $(CH_3)_2-CH-N-C(CH_3)=N-CH-(CH_3)_2$), 1.33 (12H, d, $O-CH-(CH_3)_2$), 1.47 (3H, s, $(CH_3)_2-CH-N-C(CH_3)=N-CH-(CH_3)_2$), 3.37 (6H, s, $N(CH_3)_2$), 3.46 (2H, m, $O-CH-(CH_3)_2$), 4.82 (2H, m, $(CH_3)_2-CH-N-C(H)=N-CH-(CH_3)_2$).

Example 6

Ti(Et-N-(CH₂)₂-N-Et)(OiPr)₂: To a 60 mL pentane solution containing 15.0g, 59.01 mmol, of Ti(OiPr)₂(NMe₂)₂ stirring at room temperature under atmosphere of nitrogen was added slowly drop wise neat liquid of Et-NH-(CH₂)₂-NH-Et (6.86g, 59.01 mmol). The outlet of the flask was connected to an oil bubbler, which in turn was connected to an acid scrubber. The resulting solution was stirred at room temperature overnight. Solvent and volatiles were removed from the reaction mixture under vacuum, resulting in an orange red liquid. Purification of orange red liquid by distillation resulted in a quantitative yield. **FIG 5** is a TGA graph demonstrating the percentage of weight loss with temperature change for this precursor.

NMR (C_6D_6 , δ): 1.20 (6H, t, $CH_3-CH_2-N-CH_2-CH_2-N-CH_2-CH_3$), 1.3 (12H, d, $O-CH-(CH_3)_2$), 3.5 (4H, s, $CH_3-CH_2-N-CH_2-CH_2-N-CH_2-CH_3$), 3.7 (4H, q, $(CH_3-CH_2-N-CH_2-CH_2-N-CH_2-CH_3)$), 4.7 (2H, m, $O-CH-(CH_3)_2$).

Example 7

Ti(Me-N-(CH₂)₂-N-Me)(OiPr)₂: Synthesis was carried out similar to Example 6. Purification of a red liquid by distillation resulted in decomposition of compound. NMR (C_6D_6 , δ): 1.31 (12H, d, $O-CH-(CH_3)_2$), 3.29 (6H, t, $CH_3-N-CH_2-CH_2-N-CH_3$), 3.41 (4H, s, $CH_3-N-CH_2-CH_2-N-CH_3$), 4.73 (2H, m, $O-CH-(CH_3)_2$).

Example 8

Ti(Me₂CH-N-(CH₂)₃-N-CHMe₂)(OiPr)₂: Synthesis was carried out similar to Example 6. **FIG 6** is a TGA graph demonstrating the percentage of weight loss with temperature change for this precursor.

5 NMR (C₆D₆, δ): 1.20 (6H, t, CH₃-CH₂-N-CH₂-CH₂-CH₂-N-CH₂-CH₃), 1.27 (12H, d, O-CH-(CH₃)₂), 2.23 (2H, br, CH₃-CH₂-N-CH₂-CH₂-CH₂-N-CH₂-CH₃), 3.28 (4H, q, (CH₃-CH₂-N-CH₂-CH₂-CH₂-N-CH₂-CH₃), 3.33 (4H, q, (CH₃-CH₂-N-CH₂-CH₂-CH₂-N-CH₂-CH₃), 4.55 (2H, m, O-CH-(CH₃)₂).

Example 9

10 The titanium-containing precursor of Example 1, Ti(N^{iPr}-amd)(OiPr)₃, and the reactant O₃ were used to deposit a film of TiO₂ on a SiO₂/Si substrate. The SiO₂/Si substrate was maintained at a temperature of 250°C. The precursor was vaporized in a bubbler maintained at 50°C. The ALD cycle included a precursor pulse of 5 seconds, followed by a 5 second purge, followed by a reactant pulse of 2 seconds, followed by a 5 second purge. The TiO₂ growth rate was observed to be 0.1 Å/cycle. The ALD regime was assessed up to 350°C with a deposition rate as high as 0.3 Å/cycle.

Example 10

20 The titanium-containing precursor of Example 1, Ti(N^{iPr}-amd)(OiPr)₃, and the reactant H₂O were used to deposit a film of TiO₂ on a SiO₂/Si substrate. The SiO₂/Si substrate was maintained at a temperature of 250°C. The precursor was vaporized in a bubbler maintained at 50°C. The ALD cycle included a precursor pulse of 20 seconds, followed by a 5 second purge, followed by a reactant pulse of 2 seconds, followed by a 10 second purge. The TiO₂ growth rate was observed to be 0.33 Å/cycle. The ALD regime was assessed up to 350°C with a deposition rate as high as 0.40 Å/cycle.

Example 11

30 The titanium-containing precursor of Example 2, Ti(N^{iPr}-amd)₂(OiPr)₂, and the reactant O₃ were used to deposit a film of TiO₂ on a SiO₂/Si substrate. The

SiO₂/Si substrate was maintained at a temperature of 300°C. The orange red precursor was vaporized in a bubbler maintained at 120°C. The ALD cycle included a precursor pulse of 10 seconds, followed by a 5 second purge, followed by a reactant pulse of 2 seconds, followed by a 10 second purge.

5 The TiO₂ growth rate was observed to be 0.33 Å/cycle. The ALD regime was assessed up to 325°C with a deposition rate as high as 0.40 Å/cycle.

Example 12

10 The titanium-containing precursor of Example 2, Ti(N^{iPr}-amd)₂(OiPr)₂, and the reactant H₂O were used to deposit a film of TiO₂ on a SiO₂/Si substrate. The SiO₂/Si substrate was maintained at a temperature of 275°C. The orange red precursor was vaporized in a bubbler maintained at 120°C. The ALD cycle included a precursor pulse of 10 seconds, followed by a 5 second purge, followed by a reactant pulse of 2 seconds, followed by a 5 second purge. The

15 TiO₂ growth rate was observed to be 0.40 Å/cycle. The ALD regime was assessed up to 325°C with a deposition rate as high as 0.47 Å/cycle.

Example 13

20 The titanium-containing precursor of Example 5, Ti(N^{iPr}-amd)(OiPr)₂(NMe₂), and the reactant O₃ were used to deposit a film of TiO₂ on a SiO₂/Si substrate. The SiO₂/Si substrate was maintained at a temperature of 225°C. The orange red precursor was vaporized in a bubbler maintained at 55°C. The ALD cycle included a precursor pulse of 15 seconds, followed by a 5 second purge, followed by a reactant pulse of 2 seconds, followed by a 5 second purge. The

25 TiO₂ growth rate was observed to be 0.17 Å/cycle. The ALD regime was assessed up to 375°C with a deposition rate as high as 0.70 Å/cycle.

Example 14

30 The titanium-containing precursor of Example 5, Ti(N^{iPr}-amd)(OiPr)₂(NMe₂), and the reactant H₂O were used to deposit a film of TiO₂ on a SiO₂/Si substrate. The SiO₂/Si substrate was maintained at a temperature of 225°C. The orange red precursor was vaporized in a bubbler maintained at 55°C.

The ALD cycle included a precursor pulse of 10 seconds, followed by a 10 second purge, followed by a reactant pulse of 1 second, followed by a 10 second purge. The TiO_2 growth rate was observed to be 0.73 Å/cycle. The ALD regime was assessed up to 375°C with a deposition rate as high as 0.80 Å/cycle.

Example 15

The titanium-containing precursor of Example 6, $\text{Ti}(\text{Et-N}-(\text{CH}_2)_2\text{-N-Et})(\text{OiPr})_2$, and the reactant O_3 were used to deposit a film of TiO_2 on a SiO_2/Si substrate. The SiO_2/Si substrate was maintained at a temperature of 250°C. The precursor was vaporized in a bubbler maintained at 50°C. The ALD cycle included a precursor pulse of 15 seconds, followed by a 5 second purge, followed by a reactant pulse of 2 seconds, followed by a 5 second purge. The TiO_2 growth rate was observed to be 0.1 Å/cycle. The ALD regime was assessed up to 325°C with a deposition rate as high as 0.3 Å/cycle.

Example 16

The titanium-containing precursor of Example 8, $\text{Ti}(\text{Me}_2\text{CH-N}-(\text{CH}_2)_3\text{-N-CHMe}_2)(\text{OiPr})_2$, and the reactant O_3 were used to deposit a film of TiO_2 on a SiO_2/Si substrate. The SiO_2/Si substrate was maintained at a temperature of 250°C. The precursor was vaporized in a bubbler maintained at 50°C. The ALD cycle included a precursor pulse of 15 seconds, followed by a 5 second purge, followed by a reactant pulse of 2 seconds, followed by a 5 second purge. The TiO_2 growth rate was observed to be 0.2 Å/cycle. The ALD regime was assessed up to 325°C with a deposition rate as high as 0.33 Å/cycle.

Example 17

A titanium-containing precursor having the formula $\text{Ti}(\text{OiPr})_2(\text{NMe}_2)_2$, and the reactant O_3 were used to deposit a film of TiO_2 on a SiO_2/Si substrate. The SiO_2/Si substrate was maintained at a temperature of 250°C. The precursor was vaporized in a bubbler maintained at 30°C. The ALD cycle included a

precursor pulse of 10 seconds, followed by a 5 second purge, followed by a reactant pulse of 2 seconds, followed by a 5 second purge. The TiO_2 growth rate was observed to be $0.77 \text{ \AA/cycle}$. The ALD regime was assessed up to 275°C with a deposition rate as high as $0.77 \text{ \AA/cycle}$.

5

Example 18

The titanium-containing precursor of Example 12, $\text{Ti}(\text{OiPr})_2(\text{NMe}_2)_2$, and the reactant H_2O were used to deposit a film of TiO_2 on a SiO_2/Si substrate. The SiO_2/Si substrate was maintained at a temperature of 250°C . The precursor was vaporized in a bubbler maintained at 30°C . The ALD cycle included a precursor pulse of 7 seconds, followed by a 5 second purge, followed by a reactant pulse of 2 seconds, followed by a 10 second purge. The TiO_2 growth rate was observed to be $0.25 \text{ \AA/cycle}$. The ALD regime was assessed up to 275°C with a deposition rate as high as $0.40 \text{ \AA/cycle}$.

10

15

It will be understood that many additional changes in the details, materials, steps, and arrangement of parts, which have been herein described and illustrated in order to explain the nature of the invention, may be made by those skilled in the art within the principle and scope of the invention as expressed in the appended claims. Thus, the present invention is not intended to be limited to the specific embodiments in the examples given above and/or the attached drawings.

20

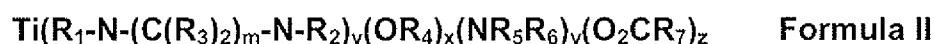
What is claimed is:

1. A molecule having the following formula:



5

or



wherein:

- R_1 , R_2 , R_5 , R_6 , and R_7 are independently selected from the group consisting of H and C1-C6 alkyl group;

10

- $\text{R}_3 = \text{H}$, C1-C6 alkyl group, or NMe_2 ;

- R_4 is a C1-C6 alkyl group;

- $m = 2\text{-}4$;

- $u = 0\text{-}2$;

- $v = 0\text{-}1$;

15

- $x = 1\text{-}3$;

- $y = 0\text{-}2$;

- $z = 0\text{-}1$;

- in Formula I, $u+x+y+z = 4$;

- in Formula II, $2v+x+y+z = 4$; and

20

- u , v , or $z \geq 1$.

2. The molecule of claim 1, the molecule having Formula I, wherein $u=1$, $x=3$, $y=0$, and $z=0$.

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3. The molecule of claim 2, wherein the molecule is selected from the group consisting of $\text{Ti}(\text{iPr-N-C}(\text{Me})\text{-N-iPr})_1(\text{OiPr})_3$, $\text{Ti}(\text{iPr-N-C}(\text{Me})\text{-N-iPr})_1(\text{OMe})_3$, $\text{Ti}(\text{iPr-N-C}(\text{Me})\text{-N-iPr})_1(\text{OEt})_3$, $\text{Ti}(\text{iPr-N-C}(\text{Me})\text{-N-iPr})_1(\text{OnPr})_3$, $\text{Ti}(\text{iPr-N-C}(\text{Me})\text{-N-iPr})_1(\text{OsBu})_3$, $\text{Ti}(\text{iPr-N-C}(\text{Me})\text{-N-iPr})_1(\text{OiBu})_3$, $\text{Ti}(\text{iPr-N-C}(\text{Me})\text{-N-iPr})_1(\text{OtBu})_3$, $\text{Ti}(\text{Et-N-C}(\text{Me})\text{-N-Et})_1(\text{OEt})_3$, $\text{Ti}(\text{Et-N-C}(\text{Me})\text{-N-Et})_1(\text{OMe})_3$, $\text{Ti}(\text{Et-N-C}(\text{Me})\text{-N-Et})_1(\text{OnPr})_3$, $\text{Ti}(\text{Et-N-C}(\text{Me})\text{-N-Et})_1(\text{OsBu})_3$, $\text{Ti}(\text{Et-N-C}(\text{Me})\text{-N-Et})_1(\text{OiBu})_3$, $\text{Ti}(\text{Et-N-C}(\text{Me})\text{-N-Et})_1(\text{OtBu})_3$, and $\text{Ti}(\text{iPr-N-C}(\text{NMe}_2)\text{-N-iPr})(\text{OiPr})_3$.

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4. The molecule of claim 1, the molecule having Formula II, wherein $v=1$, $x=2$, $y=0$, and $z=0$.

5. The molecule of claim 4, wherein the molecule is selected from the group consisting of $\text{Ti}(\text{iPr-N}-(\text{CH}_2)_2\text{-N-iPr})_1(\text{OiPr})_2$, $\text{Ti}(\text{iPr-N}-(\text{CH}_2)_2\text{-N-iPr})_1(\text{OMe})_2$, $\text{Ti}(\text{iPr-N}-(\text{CH}_2)_2\text{-N-iPr})_1(\text{OEt})_2$, $\text{Ti}(\text{iPr-N}-(\text{CH}_2)_2\text{-N-iPr})_1(\text{OnPr})_2$, $\text{Ti}(\text{iPr-N}-(\text{CH}_2)_2\text{-N-iPr})_1(\text{OsBu})_2$, $\text{Ti}(\text{iPr-N}-(\text{CH}_2)_2\text{-N-iPr})_1(\text{OiBu})_2$, $\text{Ti}(\text{iPr-N}-(\text{CH}_2)_2\text{-N-iPr})_1(\text{OtBu})_2$, $\text{Ti}(\text{Et-N}-(\text{CH}_2)_2\text{-N-Et})_1(\text{OiPr})_2$, $\text{Ti}(\text{Et-N}-(\text{CH}_2)_2\text{-N-Et})_1(\text{OMe})_2$, $\text{Ti}(\text{Et-N}-(\text{CH}_2)_2\text{-N-Et})_1(\text{OEt})_2$, $\text{Ti}(\text{Et-N}-(\text{CH}_2)_2\text{-N-Et})_1(\text{OnPr})_2$, $\text{Ti}(\text{Et-N}-(\text{CH}_2)_2\text{-N-Et})_1(\text{OsBu})_2$, $\text{Ti}(\text{Et-N}-(\text{CH}_2)_2\text{-N-Et})_1(\text{OiBu})_2$, $\text{Ti}(\text{Et-N}-(\text{CH}_2)_2\text{-N-Et})_1(\text{OtBu})_2$, $\text{Ti}(\text{iPr-N}-(\text{CH}_2)_3\text{-N-iPr})_1(\text{OiPr})_2$, $\text{Ti}(\text{iPr-N}-(\text{CH}_2)_3\text{-N-iPr})_1(\text{OMe})_2$, $\text{Ti}(\text{iPr-N}-(\text{CH}_2)_3\text{-N-iPr})_1(\text{OEt})_2$, $\text{Ti}(\text{iPr-N}-(\text{CH}_2)_3\text{-N-iPr})_1(\text{OnPr})_2$, $\text{Ti}(\text{iPr-N}-(\text{CH}_2)_3\text{-N-iPr})_1(\text{OsBu})_2$, $\text{Ti}(\text{iPr-N}-(\text{CH}_2)_3\text{-N-iPr})_1(\text{OiBu})_2$, $\text{Ti}(\text{iPr-N}-(\text{CH}_2)_3\text{-N-iPr})_1(\text{OtBu})_2$, $\text{Ti}(\text{Et-N}-(\text{CH}_2)_3\text{-N-Et})_1(\text{OiPr})_2$, $\text{Ti}(\text{Et-N}-(\text{CH}_2)_3\text{-N-Et})_1(\text{OMe})_2$, $\text{Ti}(\text{Et-N}-(\text{CH}_2)_3\text{-N-Et})_1(\text{OEt})_2$, $\text{Ti}(\text{Et-N}-(\text{CH}_2)_3\text{-N-Et})_1(\text{OnPr})_2$, $\text{Ti}(\text{Et-N}-(\text{CH}_2)_3\text{-N-Et})_1(\text{OsBu})_2$, $\text{Ti}(\text{Et-N}-(\text{CH}_2)_3\text{-N-Et})_1(\text{OiBu})_2$, and $\text{Ti}(\text{Et-N}-(\text{CH}_2)_3\text{-N-Et})_1(\text{OtBu})_2$.

6. The molecule of claim 1, the molecule having Formula I, wherein $u=2$, $x=2$, $y=0$, and $z=0$.

7. The molecule of claim 6, wherein the molecule is selected from the group consisting of $\text{Ti}(\text{iPr-N-C(H)-N-iPr})_2(\text{OiPr})_2$, $\text{Ti}(\text{iPr-N-C(H)-N-iPr})_2(\text{OMe})_2$, $\text{Ti}(\text{iPr-N-C(H)-N-iPr})_2(\text{OEt})_2$, $\text{Ti}(\text{iPr-N-C(H)-N-iPr})_2(\text{OnPr})_2$, $\text{Ti}(\text{iPr-N-C(H)-N-iPr})_2(\text{OsBu})_2$, $\text{Ti}(\text{iPr-N-C(H)-N-iPr})_2(\text{OiBu})_2$, $\text{Ti}(\text{iPr-N-C(H)-N-iPr})_2(\text{OtBu})_2$, $\text{Ti}(\text{Et-N-C(H)-N-Et})_2(\text{OiPr})_2$, $\text{Ti}(\text{Et-N-C(H)-N-Et})_2(\text{OMe})_2$, $\text{Ti}(\text{Et-N-C(H)-N-Et})_2(\text{OEt})_2$, $\text{Ti}(\text{Et-N-C(H)-N-Et})_2(\text{OnPr})_2$, $\text{Ti}(\text{Et-N-C(H)-N-Et})_2(\text{OsBu})_2$, $\text{Ti}(\text{Et-N-C(H)-N-Et})_2(\text{OiBu})_2$, $\text{Ti}(\text{Et-N-C(H)-N-Et})_2(\text{OtBu})_2$, $\text{Ti}(\text{iPr-N-C(Me)-N-iPr})_2(\text{OiPr})_2$, $\text{Ti}(\text{iPr-N-C(Me)-N-iPr})_2(\text{OMe})_2$, $\text{Ti}(\text{iPr-N-C(Me)-N-iPr})_2(\text{OEt})_2$, $\text{Ti}(\text{iPr-N-C(Me)-N-iPr})_2(\text{OnPr})_2$, $\text{Ti}(\text{iPr-N-C(Me)-N-iPr})_2(\text{OsBu})_2$, $\text{Ti}(\text{iPr-N-C(Me)-N-iPr})_2(\text{OiBu})_2$, $\text{Ti}(\text{iPr-N-C(Me)-N-iPr})_2(\text{OtBu})_2$, $\text{Ti}(\text{Et-N-C(Me)-N-Et})_2(\text{OiPr})_2$, $\text{Ti}(\text{Et-N-C(Me)-N-Et})_2(\text{OMe})_2$, $\text{Ti}(\text{Et-N-C(Me)-N-Et})_2(\text{OEt})_2$, $\text{Ti}(\text{Et-N-C(Me)-N-Et})_2(\text{OnPr})_2$, $\text{Ti}(\text{Et-N-C(Me)-N-Et})_2(\text{OsBu})_2$, $\text{Ti}(\text{Et-N-C(Me)-N-Et})_2(\text{OiBu})_2$, and $\text{Ti}(\text{Et-N-C(Me)-N-Et})_2(\text{OtBu})_2$.

N-C(Me)-N-Et)₂(OsBu)₂, Ti(Et-N-C(Me)-N-Et)₂(OiBu)₂, and Ti(Et-N-C(Me)-N-Et)₂(OtBu)₂.

8. The molecule of claim 1, the molecule having Formula I, wherein u=1,
5 x=2, y=1, and z=0.

9. The molecule of claim 8, wherein the molecule is selected from the group consisting of Ti(iPr-N-C(Me)-N-iPr)(OiPr)₂(NMe₂), Ti(iPr-N-C(Me)-N-iPr)(OiPr)₂(NEt₂), Ti(iPr-N-C(Me)-N-iPr)(OiPr)₂(NEtMe), Ti(Et-N-C(Me)-N-Et)(OiPr)₂(NMe₂), Ti(Et-N-C(Me)-N-Et)(OiPr)₂(NEt₂), Ti(Et-N-C(Me)-N-Et)(OiPr)₂(NEtMe), Ti(iPr-N-C(NMe₂)-N-iPr)(OiPr)₂(NMe₂), Ti(iPr-N-C(NMe₂)-N-iPr)(OiPr)₂(NEt₂), Ti(iPr-N-C(NMe₂)-N-iPr)(OiPr)₂(NEtMe), Ti(iPr-N-C(Me)-N-iPr)(OiPr)₂(NMeiPr), Ti(iPr-N-C(Me)-N-iPr)(OiPr)₂(NiPr₂), Ti(iPr-N-C(Me)-N-iPr)(OiPr)₂(NmetBu), Ti(iPr-N-C(Me)-N-iPr)(OiPr)₂(NneoPentyl₂), Ti(Et-N-C(Me)-N-Et)(OiPr)₂(NMeiPr), Ti(Et-N-C(Me)-N-Et)(OiPr)₂(NiPr₂), Ti(Et-N-C(Me)-N-Et)(OiPr)₂(NneoPentyl₂), Ti(iPr-N-C(NMe₂)-N-iPr)(OiPr)₂(NMeiPr), Ti(iPr-N-C(NMe₂)-N-iPr)(OiPr)₂(NiPr₂), Ti(iPr-N-C(NMe₂)-N-iPr)(OiPr)₂(NneoPentyl₂), and Ti(iPr-N-C(NMe₂)-N-iPr)(OiPr)₂(NMeiPr);
10
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10. The molecule of claim 1, the molecule having Formula I, wherein u=1,
20 x=2, y=0, and z=1.

11. The molecule of claim 10, wherein the molecule is selected from the group consisting of Ti(iPr-N-C(Me)-N-iPr)(OiPr)₂(O₂CMe) and Ti(Et-N-C(Me)-N-Et)(OiPr)₂(O₂CMe).
25

12. The molecule of claim 1, the molecule having Formula II, wherein v=1,
x=1, y=0, and z=1.

13. The molecule of claim 12, wherein the molecule is selected from the group consisting of Ti(iPr-N-(CH₂)₂-N-iPr)(OiPr)(O₂CMe), Ti(iPr-N-(CH₂)₂-N-iPr)(OMe)(O₂CMe), Ti(iPr-N-(CH₂)₂-N-iPr)(OEt)(O₂CMe), Ti(iPr-N-(CH₂)₂-N-
30

iPr)(OnPr)(O₂CMe), Ti(iPr-N-(CH₂)₂-N-iPr)(OsBu)(O₂CMe), Ti(iPr-N-(CH₂)₂-N-iPr)(OiBu)(O₂CMe), Ti(iPr-N-(CH₂)₂-N-iPr)(OtBu)(O₂CMe), Ti(Et-N-(CH₂)₂-N-Et)(OiPr)(O₂CMe), Ti(Et-N-(CH₂)₂-N-Et)(OMe)(O₂CMe), Ti(Et-N-(CH₂)₂-N-Et)(OEt)(O₂CMe), Ti(Et-N-(CH₂)₂-N-Et)(OnPr)(O₂CMe), Ti(Et-N-(CH₂)₂-N-Et)(OsBu)(O₂CMe), Ti(Et-N-(CH₂)₂-N-Et)(OiBu)(O₂CMe), and Ti(Et-N-(CH₂)₂-N-Et)(OtBu)(O₂CMe).

14. The molecule of claim 1, the molecule having either Formula I or Formula II, wherein u, v, y=0, x=2, and z=2.

15. The molecule of claim 14, the molecule being Ti(OiPr)₂(O₂CMe)₂.

16. The molecule of claim 1, the molecule having either Formula I or Formula II, wherein u, v, y=0, x=3, and z=1.

17. The molecule of claim 16, the molecule being Ti(OiPr)₃(O₂CMe).

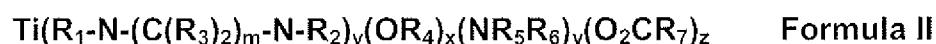
18. A method of forming a Ti-containing layer on a substrate, the method comprising:

providing a reaction chamber having at least one substrate disposed therein;

introducing into the reaction chamber a vapor including at least one precursor having the formula:



or



wherein:

- R₁, R₂, R₅, R₆, and R₇ are independently selected from the group consisting of H and C1-C6 alkyl group;

- R₃ = H, C1-C6 alkyl group, or NMe₂;

- R₄ is a C1-C6 alkyl group;

- m = 2-4;

N-C(H)-N-Et)₂(OiPr)₂, Ti(Et-N-C(H)-N-Et)₂(OMe)₂, Ti(Et-N-C(H)-N-Et)₂(OEt)₂,
 Ti(Et-N-C(H)-N-Et)₂(OnPr)₂, Ti(Et-N-C(H)-N-Et)₂(OsBu)₂, Ti(Et-N-C(H)-N-
 Et)₂(OiBu)₂, Ti(Et-N-C(H)-N-Et)₂(OtBu)₂, Ti(iPr-N-C(Me)-N-iPr)₂(OiPr)₂, Ti(iPr-
 N-C(Me)-N-iPr)₂(OMe)₂, Ti(iPr-N-C(Me)-N-iPr)₂(OEt)₂, Ti(iPr-N-C(Me)-N-
 iPr)₂(OnPr)₂, Ti(iPr-N-C(Me)-N-iPr)₂(OsBu)₂, Ti(iPr-N-C(Me)-N-iPr)₂(OiBu)₂,
 Ti(iPr-N-C(Me)-N-iPr)₂(OtBu)₂, Ti(Et-N-C(Me)-N-Et)₂(OiPr)₂, Ti(Et-N-C(Me)-N-
 Et)₂(OMe)₂, Ti(Et-N-C(Me)-N-Et)₂(OEt)₂, Ti(Et-N-C(Me)-N-Et)₂(OnPr)₂, Ti(Et-
 N-C(Me)-N-Et)₂(OsBu)₂, Ti(Et-N-C(Me)-N-Et)₂(OiBu)₂, Ti(Et-N-C(Me)-N-
 Et)₂(OtBu)₂, Ti(iPr-N-C(Me)-N-iPr)(OiPr)₂(NMe₂), Ti(iPr-N-C(Me)-N-
 iPr)(OiPr)₂(NEt₂), Ti(iPr-N-C(Me)-N-iPr)(OiPr)₂(NEtMe), Ti(Et-N-C(Me)-N-
 Et)(OiPr)₂(NMe₂), Ti(Et-N-C(Me)-N-Et)(OiPr)₂(NEt₂), Ti(Et-N-C(Me)-N-
 Et)(OiPr)₂(NEtMe), Ti(iPr-N-C(NMe₂)-N-iPr)(OiPr)₂(NMe₂), Ti(iPr-N-C(NMe₂)-
 N-iPr)(OiPr)₂(NEt₂), Ti(iPr-N-C(NMe₂)-N-iPr)(OiPr)₂(NEtMe), Ti(iPr-N-C(Me)-
 N-iPr)(OiPr)₂(O₂CMe), Ti(Et-N-C(Me)-N-Et)(OiPr)₂(O₂CMe), Ti(iPr-N-(CH₂)₂-N-
 iPr)(OiPr)(O₂CMe), Ti(iPr-N-(CH₂)₂-N-iPr)(OMe)(O₂CMe), Ti(iPr-N-(CH₂)₂-N-
 iPr)(OEt)(O₂CMe), Ti(iPr-N-(CH₂)₂-N-iPr)(OnPr)(O₂CMe), Ti(iPr-N-(CH₂)₂-N-
 iPr)(OsBu)(O₂CMe), Ti(iPr-N-(CH₂)₂-N-iPr)(OiBu)(O₂CMe), Ti(iPr-N-(CH₂)₂-N-
 iPr)(OtBu)(O₂CMe), Ti(Et-N-(CH₂)₂-N-Et)(OiPr)(O₂CMe), Ti(Et-N-(CH₂)₂-N-
 Et)(OMe)(O₂CMe), Ti(Et-N-(CH₂)₂-N-Et)(OEt)(O₂CMe), Ti(Et-N-(CH₂)₂-N-
 Et)(OnPr)(O₂CMe), Ti(Et-N-(CH₂)₂-N-Et)(OsBu)(O₂CMe), Ti(Et-N-(CH₂)₂-N-
 Et)(OiBu)(O₂CMe), Ti(Et-N-(CH₂)₂-N-Et)(OtBu)(O₂CMe), Ti(OiPr)₂(O₂CMe)₂,
 and Ti(OiPr)₃(O₂CMe).

20. The method of claim 19, further comprising:

25 introducing into the reaction chamber a second vapor including at least
 one metal-containing precursor selected from the group consisting of M(L)₂
 and M(L)₂.A, wherein:

- M is Sr or Ba;
- L is selected from substituted cyclopentadienyl ligand systems
 30 R₁R₂R₃R₄R₅Cp or beta-diketonate ligand systems -O-CR₆-CH-CR₇-O-;
 - each of R₁ to R₅ is independently selected from H or C1-C6
 linear or branched alkyl chain;

- each of R_6 and R_7 is independently selected from C1-C6 linear or branched alkyl chain; and

- A is a neutral oxygen containing molecules selected from the group consisting of tetrahydrofuran, dimethoxyethane, diglyme, triglyme, and tetraglyme; and

contacting the second vapor with the substrate to form a metal-containing layer on at least one surface of the substrate using the vapor deposition process.

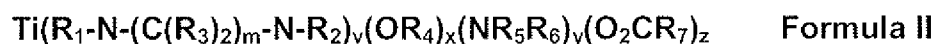
21. The method of claim 20, wherein the metal-containing precursor is selected from the group consisting of $Sr(iPr_3Cp)_2$, $Sr(iPr_3Cp)_2.thf$, $Sr(iPr_3Cp)_2.dme$, $Sr(tBu_3Cp)_2$, $Sr(tBu_3Cp)_2.thf$, $Sr(tBu_3Cp)_2.dme$, $Sr(thmd)_2$, $Sr(thmd)_2.triglyme$, $Sr(thmd)_2.tetraglyme$, $Sr(Me_5Cp)_2$, $Sr(Me_4Cp)_2$, $Sr(Me_4EtCp)_2$, $Sr(Me_4nBuCp)_2$, $Ba(iPr_3Cp)_2$, $Ba(iPr_3Cp)_2.thf$, $Ba(iPr_3Cp)_2.dme$, $Ba(tBu_3Cp)_2$, $Ba(tBu_3Cp)_2.thf$, $Ba(tBu_3Cp)_2.dme$, $Ba(thmd)_2$, $Ba(thmd)_2.triglyme$, $Ba(thmd)_2.tetraglyme$, $Ba(Me_5Cp)_2$, $Ba(Me_4Cp)_2$, $Ba(Me_4EtCp)_2$, and $Ba(Me_4nBuCp)_2$.

22. A method of depositing a STO or BST film, the method comprising: providing an ALD reaction chamber having at least one substrate disposed therein;

pulsing into the reaction chamber a precursor having the formula:



or



wherein:

- R_1 , R_2 , R_5 , R_6 , and R_7 are independently selected from the group consisting of H and C1-C6 alkyl group;
- R_3 = H, C1-C6 alkyl group, or NMe_2 ;
- R_4 is a C1-C6 alkyl group;
- m = 2-4;
- u = 0-2;

- $v = 0-1$;
- $x = 1-3$;
- $y = 0-2$;
- $z = 0-1$;
- 5 ▪ in Formula I, $u+x+y+z = 4$;
- in Formula II, $2v+x+y+z = 4$; and
- $u, v, \text{ or } z \geq 1$; and

pulsing into the reaction chamber an oxygen source;

pulsing into the reaction chamber a metal-containing precursor

10 selected from the group consisting of $M(L)_2$ and $M(L)_2.A$, wherein:

- M is Sr or Ba;
- L is selected from substituted cyclopentadienyl ligand systems $R_1R_2R_3R_4R_5Cp$ or beta-diketonate ligand systems $-O-CR_6-CH-CR_7-O-$;
- each of R_1 to R_5 is independently selected from H or C1-C6

15 linear or branched alkyl chain;

- each of R_6 and R_7 is independently selected from C1-C6 linear or branched alkyl chain; and

- A is a neutral oxygen containing molecules selected from the group consisting of tetrahydrofuran, dimethoxyethane, diglyme,

20 triglyme, and tetraglyme;

pulsing into the reaction chamber a second oxygen source; and

controlling the stoichiometry of M:Ti ratio in the STO or BST film by varying a number of the pulsing steps for the precursor and metal-containing precursor.

25 23. The method of claim 22, wherein the precursor is selected from the group consisting of $Ti(iPr-N-C(Me)-N-iPr)_1(OiPr)_3$, $Ti(iPr-N-C(Me)-N-iPr)_1(OMe)_3$, $Ti(iPr-N-C(Me)-N-iPr)_1(OEt)_3$, $Ti(iPr-N-C(Me)-N-iPr)_1(OnPr)_3$, $Ti(iPr-N-C(Me)-N-iPr)_1(OsBu)_3$, $Ti(iPr-N-C(Me)-N-iPr)_1(OiBu)_3$, $Ti(iPr-N-C(Me)-N-iPr)_1(OtBu)_3$, $Ti(Et-N-C(Me)-N-Et)_1(OEt)_3$, $Ti(Et-N-C(Me)-N-Et)_1(OMe)_3$, $Ti(Et-N-C(Me)-N-Et)_1(OnPr)_3$, $Ti(Et-N-C(Me)-N-Et)_1(OsBu)_3$, $Ti(Et-N-C(Me)-N-Et)_1(OiBu)_3$, $Ti(Et-N-C(Me)-N-Et)_1(OtBu)_3$, $Ti(iPr-N-C(NMe_2)-N-iPr)(OiPr)_3$,

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Ti(iPr-N-(CH₂)₂-N-iPr)₁(OiPr)₂, Ti(iPr-N-(CH₂)₂-N-iPr)₁(OMe)₂, Ti(iPr-N-(CH₂)₂-N-iPr)₁(OEt)₂, Ti(iPr-N-(CH₂)₂-N-iPr)₁(OnPr)₂, Ti(iPr-N-(CH₂)₂-N-iPr)₁(OsBu)₂,
 Ti(iPr-N-(CH₂)₂-N-iPr)₁(OiBu)₂, Ti(iPr-N-(CH₂)₂-N-iPr)₁(OtBu)₂, Ti(Et-N-(CH₂)₂-N-Et)₁(OiPr)₂, Ti(Et-N-(CH₂)₂-N-Et)₁(OMe)₂, Ti(Et-N-(CH₂)₂-N-Et)₁(OEt)₂, Ti(Et-
 5 N-(CH₂)₂-N-Et)₁(OnPr)₂, Ti(Et-N-(CH₂)₂-N-Et)₁(OsBu)₂, Ti(Et-N-(CH₂)₂-N-Et)₁(OiBu)₂, Ti(Et-N-(CH₂)₂-N-Et)₁(OtBu)₂, Ti(iPr-N-(CH₂)₃-N-iPr)₁(OiPr)₂,
 Ti(iPr-N-(CH₂)₃-N-iPr)₁(OMe)₂, Ti(iPr-N-(CH₂)₃-N-iPr)₁(OEt)₂, Ti(iPr-N-(CH₂)₃-N-iPr)₁(OnPr)₂, Ti(iPr-N-(CH₂)₃-N-iPr)₁(OsBu)₂, Ti(iPr-N-(CH₂)₃-N-iPr)₁(OiBu)₂,
 Ti(iPr-N-(CH₂)₃-N-iPr)₁(OtBu)₂, Ti(Et-N-(CH₂)₃-N-Et)₁(OiPr)₂, Ti(Et-N-(CH₂)₃-N-Et)₁(OMe)₂, Ti(Et-N-(CH₂)₃-N-Et)₁(OEt)₂, Ti(Et-N-(CH₂)₃-N-Et)₁(OnPr)₂, Ti(Et-
 10 N-(CH₂)₃-N-Et)₁(OsBu)₂, Ti(Et-N-(CH₂)₃-N-Et)₁(OiBu)₂, Ti(Et-N-(CH₂)₃-N-Et)₁(OtBu)₂, Ti(iPr-N-C(H)-N-iPr)₂(OiPr)₂, Ti(iPr-N-C(H)-N-iPr)₂(OMe)₂, Ti(iPr-N-C(H)-N-iPr)₂(OEt)₂, Ti(iPr-N-C(H)-N-iPr)₂(OnPr)₂, Ti(iPr-N-C(H)-N-iPr)₂(OsBu)₂, Ti(iPr-N-C(H)-N-iPr)₂(OiBu)₂, Ti(iPr-N-C(H)-N-iPr)₂(OtBu)₂, Ti(Et-
 15 N-C(H)-N-Et)₂(OiPr)₂, Ti(Et-N-C(H)-N-Et)₂(OMe)₂, Ti(Et-N-C(H)-N-Et)₂(OEt)₂, Ti(Et-N-C(H)-N-Et)₂(OnPr)₂, Ti(Et-N-C(H)-N-Et)₂(OsBu)₂, Ti(Et-N-C(H)-N-Et)₂(OiBu)₂, Ti(Et-N-C(H)-N-Et)₂(OtBu)₂, Ti(iPr-N-C(Me)-N-iPr)₂(OiPr)₂, Ti(iPr-N-C(Me)-N-iPr)₂(OMe)₂, Ti(iPr-N-C(Me)-N-iPr)₂(OEt)₂, Ti(iPr-N-C(Me)-N-iPr)₂(OnPr)₂, Ti(iPr-N-C(Me)-N-iPr)₂(OsBu)₂, Ti(iPr-N-C(Me)-N-iPr)₂(OiBu)₂,
 20 Ti(iPr-N-C(Me)-N-iPr)₂(OtBu)₂, Ti(Et-N-C(Me)-N-Et)₂(OiPr)₂, Ti(Et-N-C(Me)-N-Et)₂(OMe)₂, Ti(Et-N-C(Me)-N-Et)₂(OEt)₂, Ti(Et-N-C(Me)-N-Et)₂(OnPr)₂, Ti(Et-N-C(Me)-N-Et)₂(OsBu)₂, Ti(Et-N-C(Me)-N-Et)₂(OiBu)₂, Ti(Et-N-C(Me)-N-Et)₂(OtBu)₂, Ti(iPr-N-C(Me)-N-iPr)(OiPr)₂(NMe₂), Ti(iPr-N-C(Me)-N-iPr)(OiPr)₂(NEt₂), Ti(iPr-N-C(Me)-N-iPr)(OiPr)₂(NEtMe), Ti(Et-N-C(Me)-N-Et)(OiPr)₂(NMe₂), Ti(Et-N-C(Me)-N-Et)(OiPr)₂(NEt₂), Ti(Et-N-C(Me)-N-Et)(OiPr)₂(NEtMe), Ti(iPr-N-C(NMe₂)-N-iPr)(OiPr)₂(NMe₂), Ti(iPr-N-C(NMe₂)-N-iPr)(OiPr)₂(NEt₂), Ti(iPr-N-C(NMe₂)-N-iPr)(OiPr)₂(NEtMe), Ti(iPr-N-C(Me)-N-iPr)(OiPr)₂(O₂CMe), Ti(Et-N-C(Me)-N-Et)(OiPr)₂(O₂CMe), Ti(iPr-N-(CH₂)₂-N-iPr)(OiPr)(O₂CMe), Ti(iPr-N-(CH₂)₂-N-iPr)(OMe)(O₂CMe), Ti(iPr-N-(CH₂)₂-N-iPr)(OEt)(O₂CMe), Ti(iPr-N-(CH₂)₂-N-iPr)(OnPr)(O₂CMe), Ti(iPr-N-(CH₂)₂-N-iPr)(OsBu)(O₂CMe), Ti(iPr-N-(CH₂)₂-N-iPr)(OiBu)(O₂CMe), Ti(iPr-N-(CH₂)₂-N-iPr)(OtBu)(O₂CMe), Ti(Et-N-(CH₂)₂-N-Et)(OiPr)(O₂CMe), Ti(Et-N-(CH₂)₂-N-
 30

Et)(OMe)(O₂CMe), Ti(Et-N-(CH₂)₂-N-Et)(OEt)(O₂CMe), Ti(Et-N-(CH₂)₂-N-Et)(OnPr)(O₂CMe), Ti(Et-N-(CH₂)₂-N-Et)(OsBu)(O₂CMe), Ti(Et-N-(CH₂)₂-N-Et)(OiBu)(O₂CMe), Ti(Et-N-(CH₂)₂-N-Et)(OtBu)(O₂CMe), Ti(OiPr)₂(O₂CMe)₂, and Ti(OiPr)₃(O₂CMe).

5

24. The method of claim 22, wherein the metal-containing precursor is selected from the group consisting of Sr(iPr₃Cp)₂, Sr(iPr₃Cp)₂.thf, Sr(iPr₃Cp)₂.dme, Sr(tBu₃Cp)₂, Sr(tBu₃Cp)₂.thf, Sr(tBu₃Cp)₂.dme, Sr(thmd)₂, Sr(thmd)₂.triglyme, Sr(thmd)₂.tetraglyme, Sr(Me₅Cp)₂, Sr(Me₄Cp)₂,
 10 Sr(Me₄EtCp)₂, Sr(Me₄nBuCp)₂, Ba(iPr₃Cp)₂, Ba(iPr₃Cp)₂.thf, Ba(iPr₃Cp)₂.dme, Ba(tBu₃Cp)₂, Ba(tBu₃Cp)₂.thf, Ba(tBu₃Cp)₂.dme, Ba(thmd)₂, Ba(thmd)₂.triglyme, Ba(thmd)₂.tetraglyme, Ba(Me₅Cp)₂, Ba(Me₄Cp)₂, Ba(Me₄EtCp)₂, and Ba(Me₄nBuCp)₂.

15

25. The method of claim 22, wherein the oxygen source and the second oxygen source are water.